

# Transport through Nanostructures

Sibylle Gemming

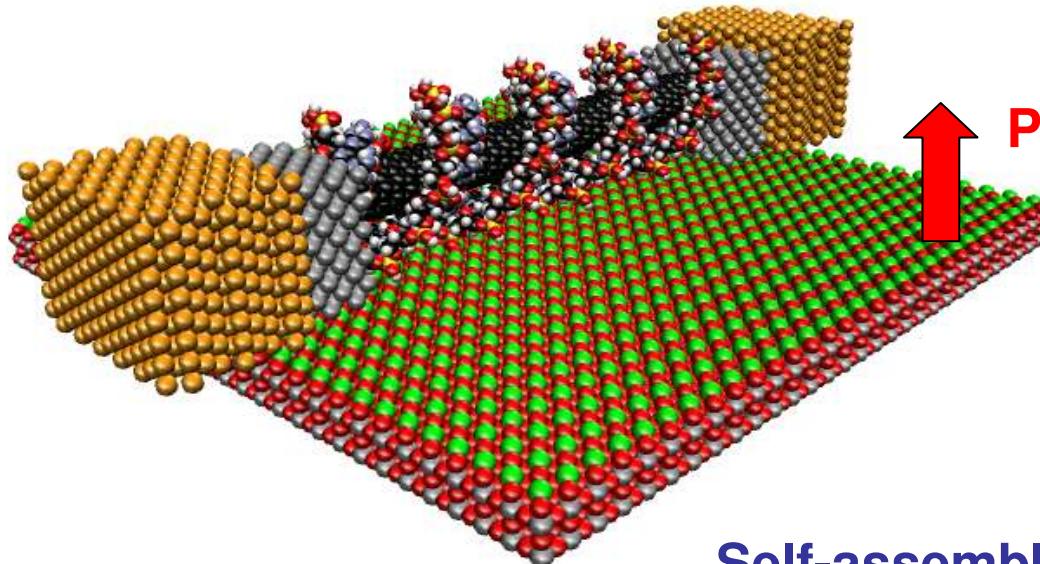
Institut für Ionenstrahlphysik und Materialforschung  
Forschungszentrum Dresden-Rossendorf  
Pf 510119, D-01314 Dresden



**Forschungszentrum**  
**Dresden** Rossendorf

# Organic field-effect transistor on ferroic substrate

## FET-prototype



**Self-assembled monolayer gate?**

**Continuous wire/tube gate?**

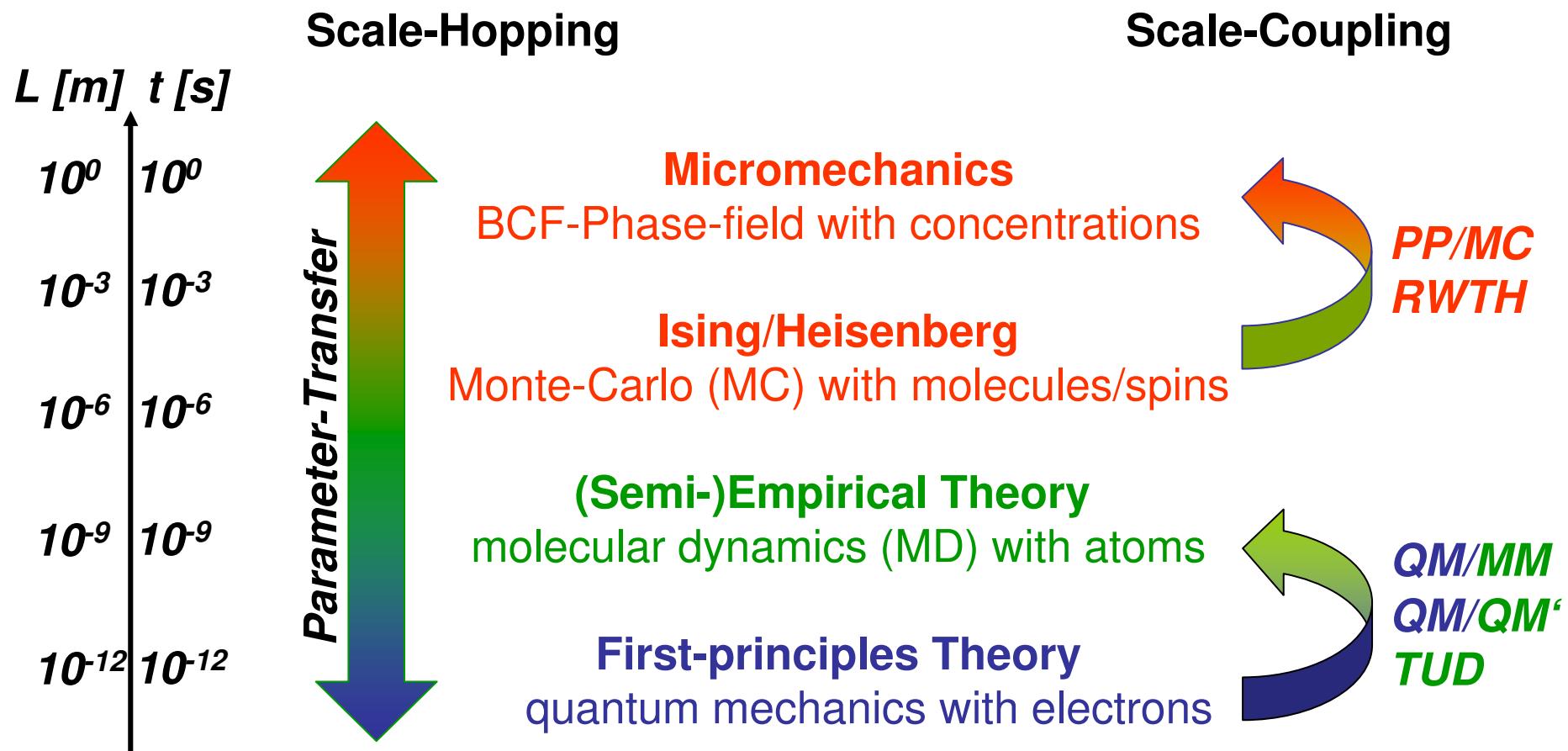
**Switching?**

Gate: (7,3)CNT @ polyG-DNA

Contact: Ti/Au electrodes

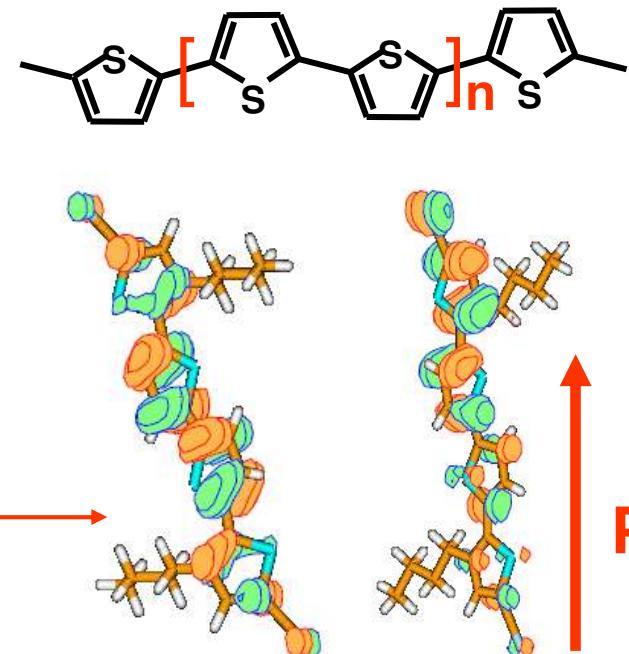
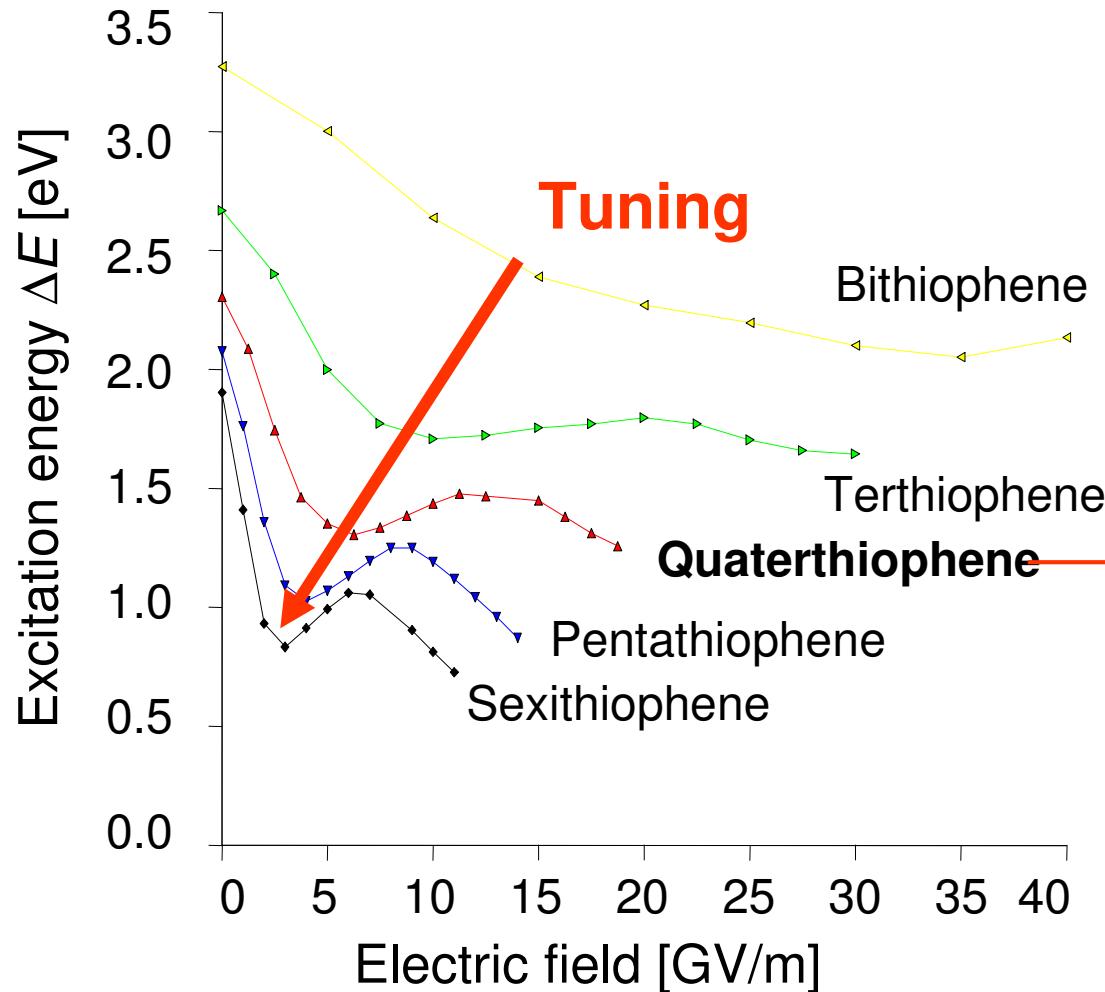
Field: BaTiO<sub>3</sub> surface polarisation

# Scale-bridging approaches



# Self-assembled monolayer gate Thiophenes

## Field sensitivity of oligothiophenes

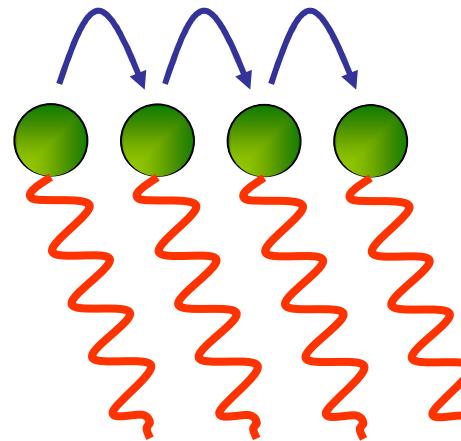
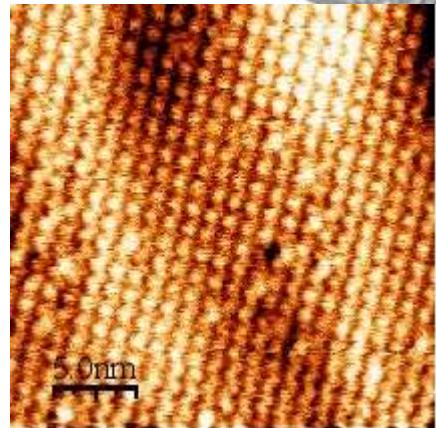
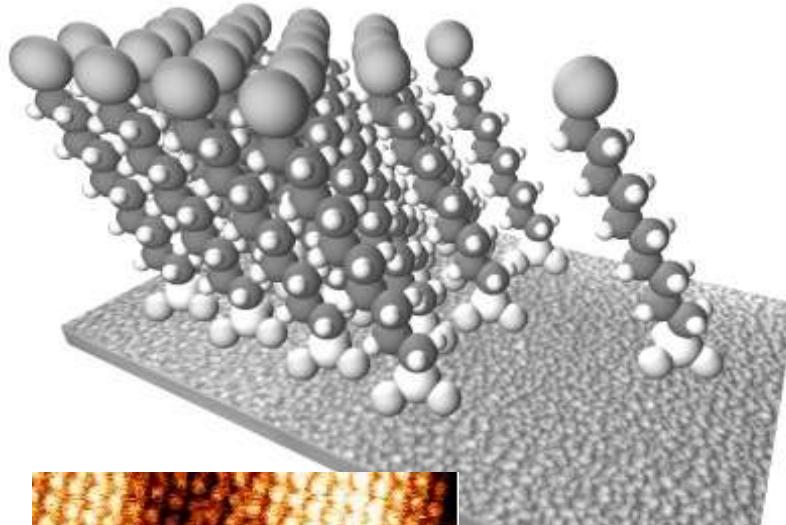


J Computer-Aided Mater Des (2007) 14:211–218  
DOI 10.1007/s10820-007-9076-7

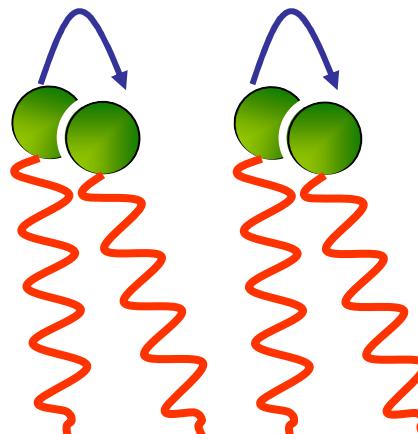
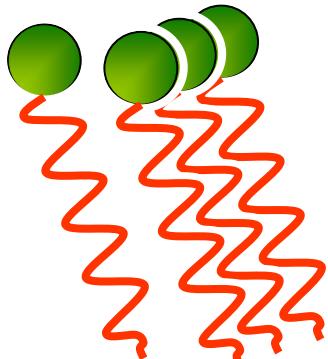
**Modelling ferroic functional elements**  
**S. Gemming · R. Luschnitz · W. Alsheimer**  
**G. Seifert · Ch. Loppacher · L. M. Eng**

## Transport mechanisms

### Self-organized QT layer

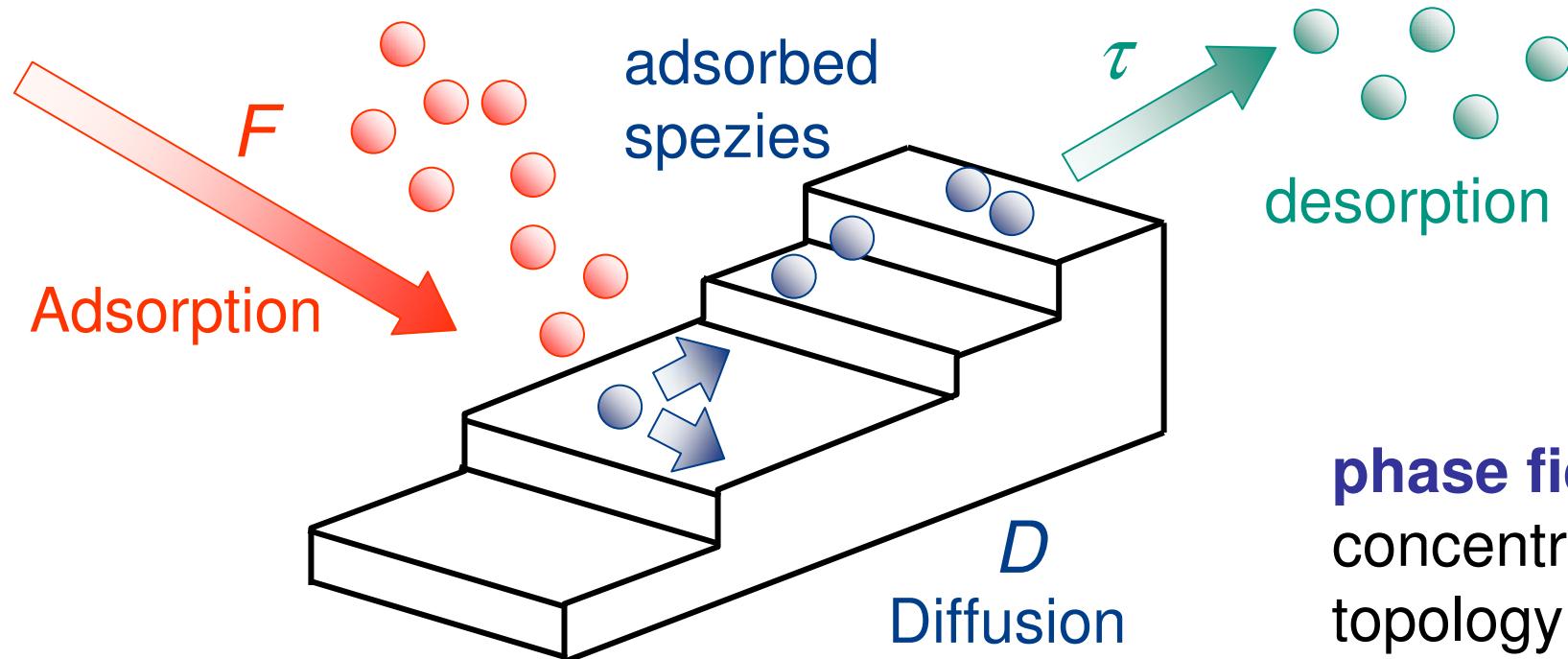


**Hopping**  
classical  
master equation  
semi-classical  
tight-binding



**Shuttling**  
classical  
elasto-mechanics

## Self-assembly – Burton-Cabrera-Franck



phase field  
concentration  $n$   
topology  $\psi$

DFT-HF/MP2

interactions

molecule-molecule  
molecule-surface

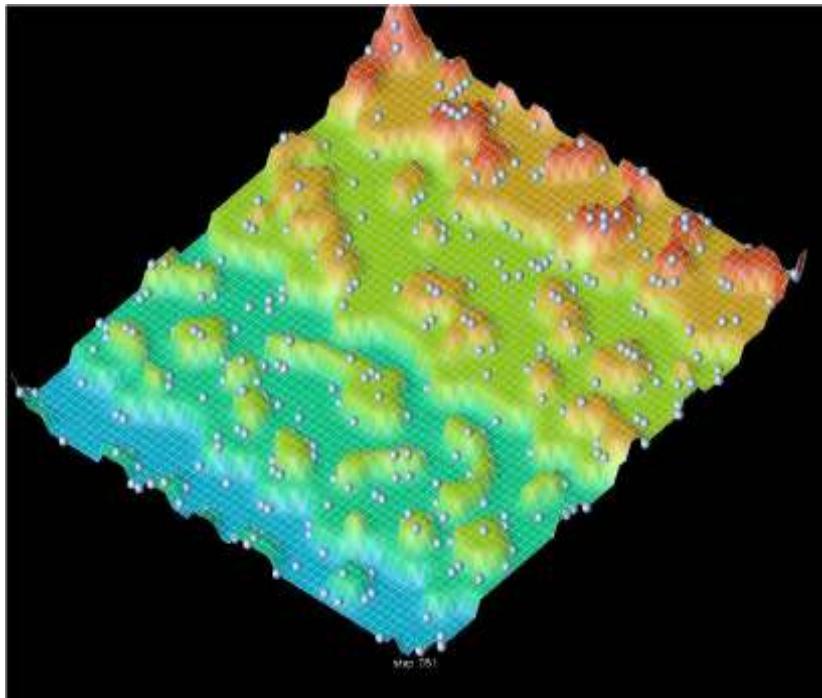
J, H

Metropolis-  
Monte-Carlo

$\langle D \rangle, \langle \tau \rangle, \langle n \rangle$

## Growth modes on structured surfaces

Island – layer-growth

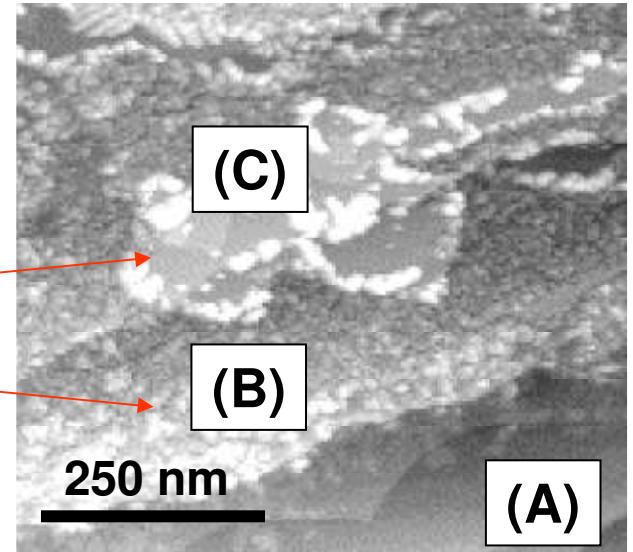


( $T = 400$  K,  $D = 3.2 \times 10^5$  a<sup>2</sup>/s,  
 $F = 3$  ML/ms,  $\tau = 10^4$  s)

Radke, Kundin, Emmerich, Gemming,  
*Physica D 238* (2009) 117-125.

PTCDA on  
KBr|Ag

layer  
islands



( $f_0 = 155.926$  kHz,  $k = 40$  N/m,  
 $\Delta f = 34$  Hz,  $A_0 = 1.7$  nm)

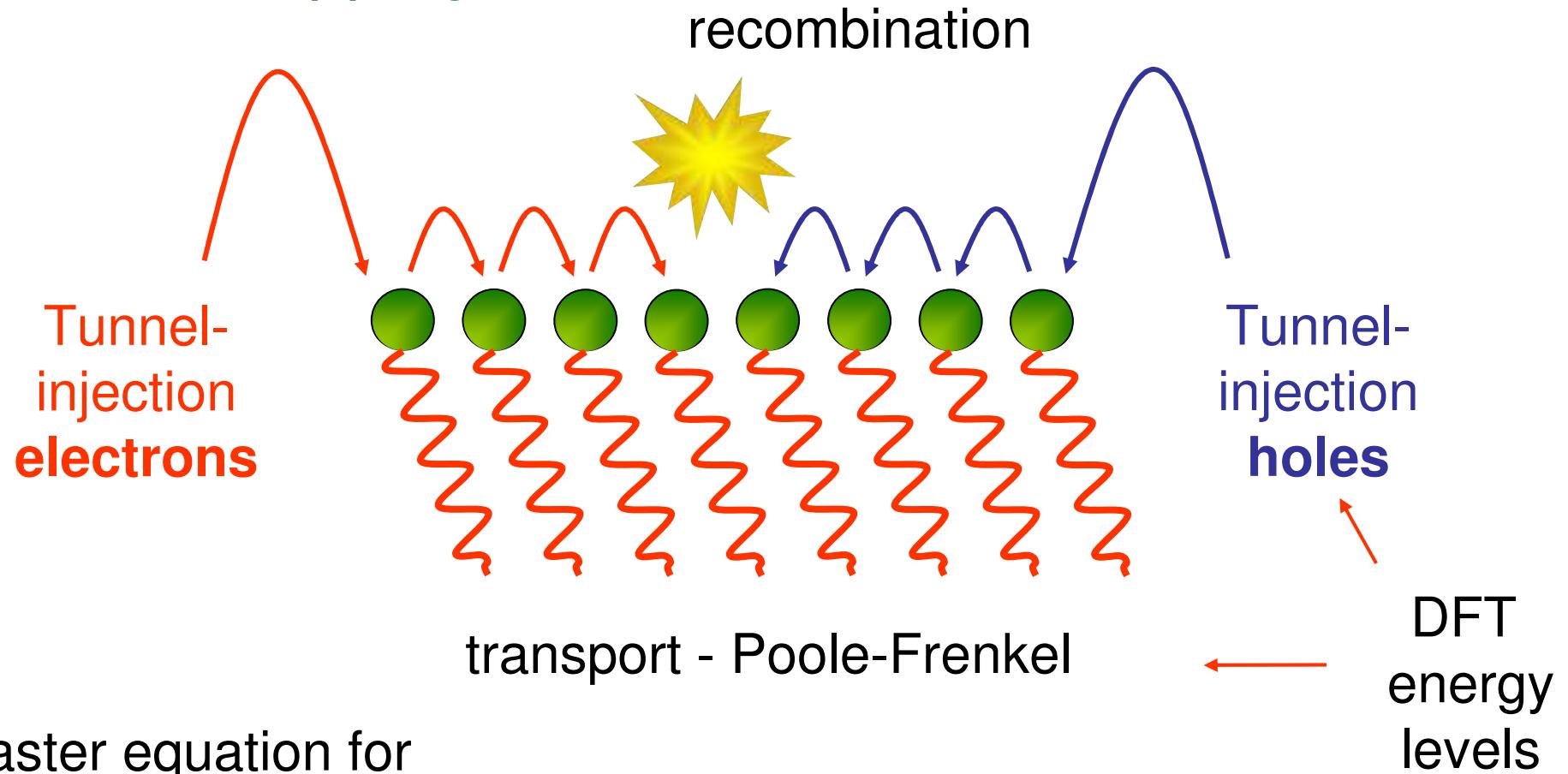
INSTITUTE OF PHYSICS PUBLISHING

Nanotechnology 17 (2006) 1568–1573

## Adsorption of PTCDA on a partially KBr covered Ag(111) substrate

Ch Loppacher<sup>1,4</sup>, U Zerweck<sup>1</sup>, L M Eng<sup>1</sup>, S Gemming<sup>2</sup>, G Seifert<sup>2</sup>,  
C Olbrich<sup>3</sup>, K Morawetz<sup>3</sup> and M Schreiber<sup>3</sup>

## Classical hopping

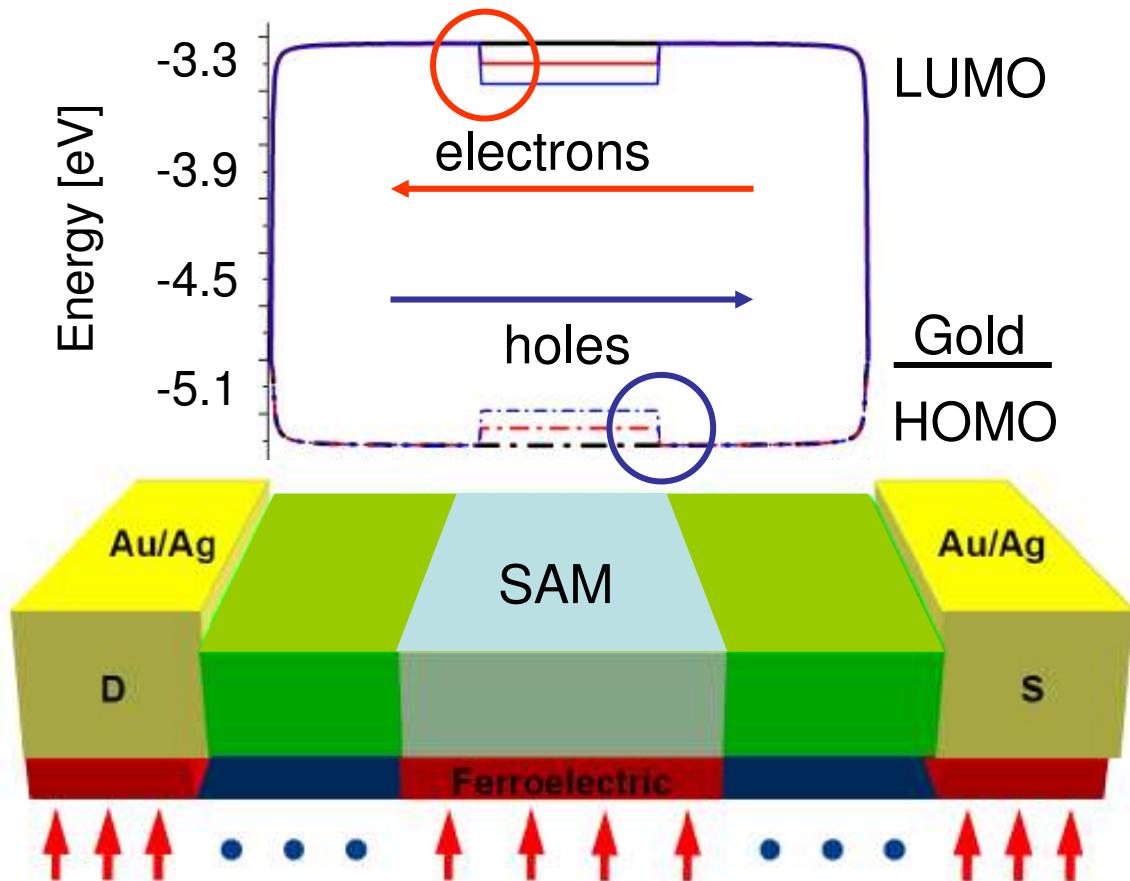


Master equation for carrier densities at each site i

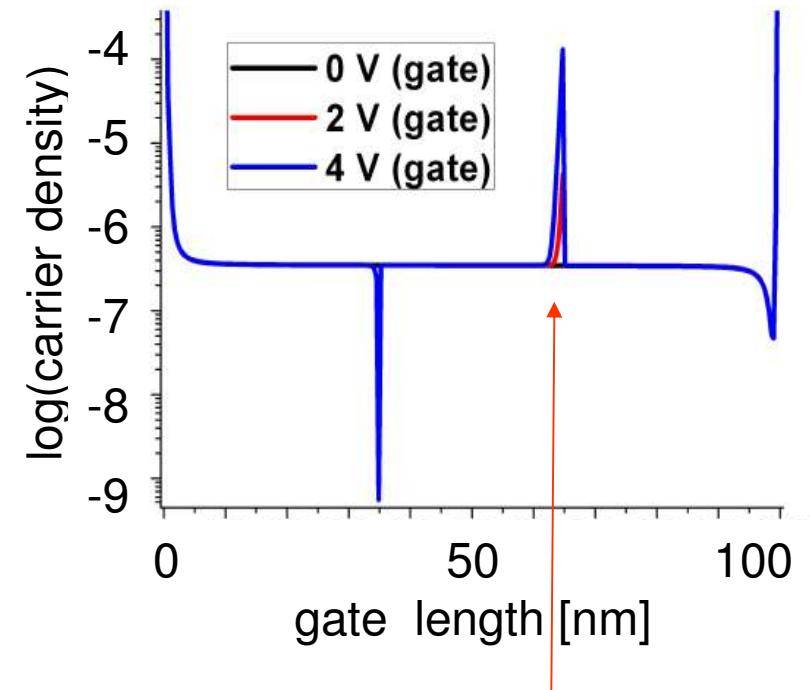
$$n_{\text{new}}^i = n_{\text{old}}^i + \Delta n_{\text{trans}}^i + \Delta n_{\text{tunn}}^i - \Delta n_{\text{rec}}^i$$

## Hopping transport

Ferroelectric domain:  $\Delta E$



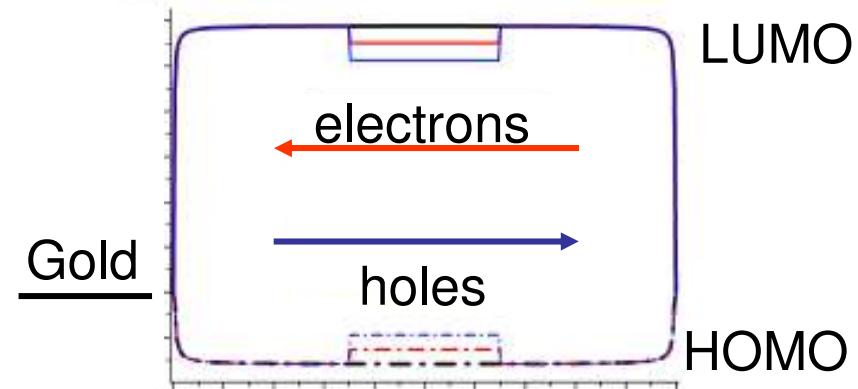
Majority carrier: holes



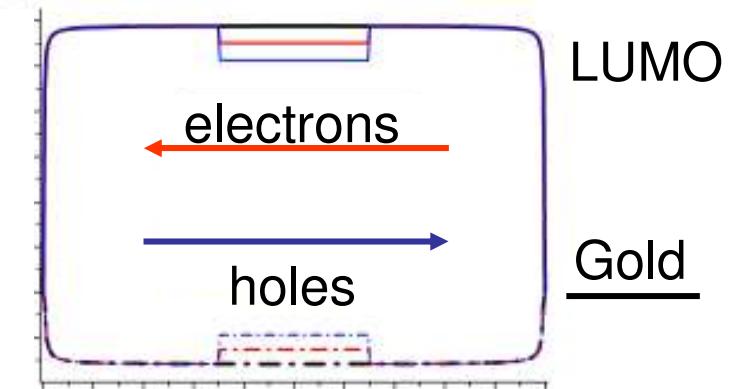
accumulation  
increased mobility

## Hopping transport - Modifications

Contact metal

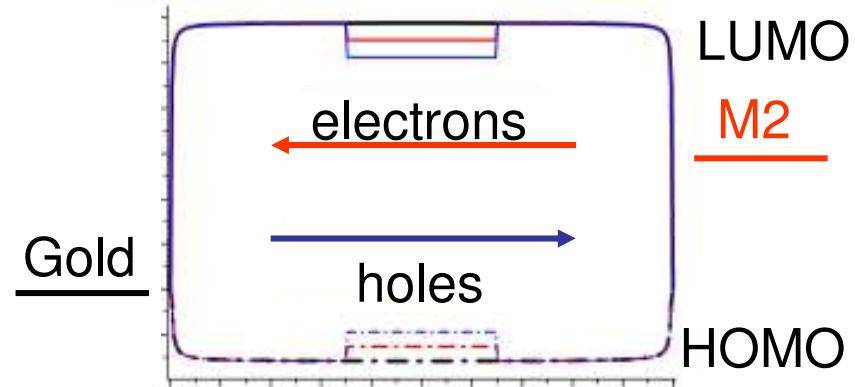


Anchoring group

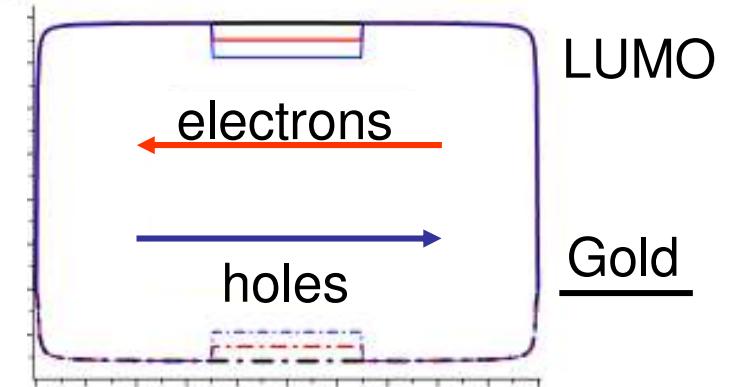


## Hopping transport - Modifications

Contact metal



Anchoring group



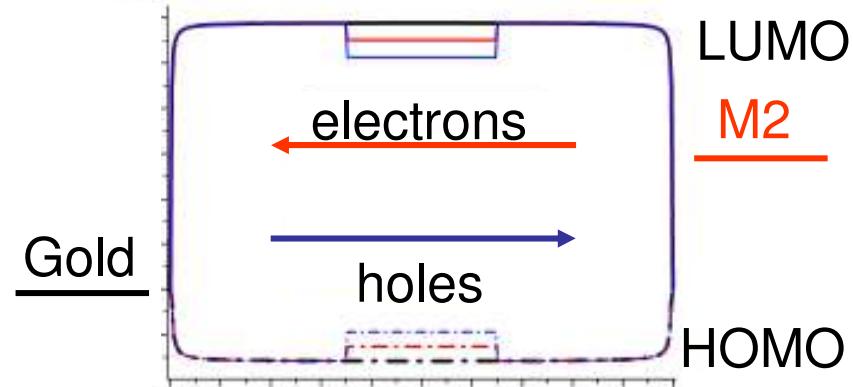
two-level transport  
diode effect

Nikolai B Zhitenev<sup>1,3</sup>, Artur Erbe<sup>1,4</sup>, Zhenan Bao<sup>1,5</sup>,  
Weirong Jiang<sup>1,2</sup> and Eric Garfunkel<sup>2</sup>

Nanotechnology **16** (2005) 495–500

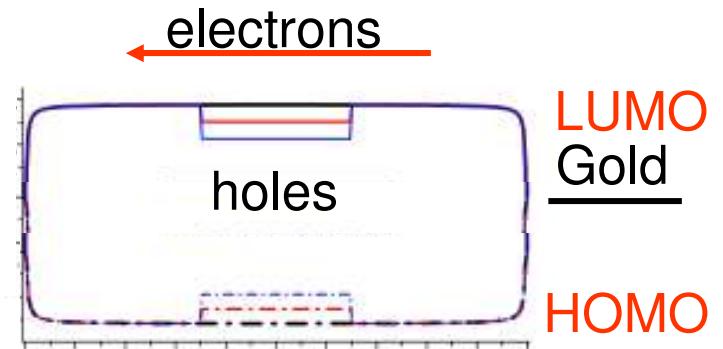
## Hopping transport - Modifications

Contact metal



two-level transport  
diode effect

Anchoring group



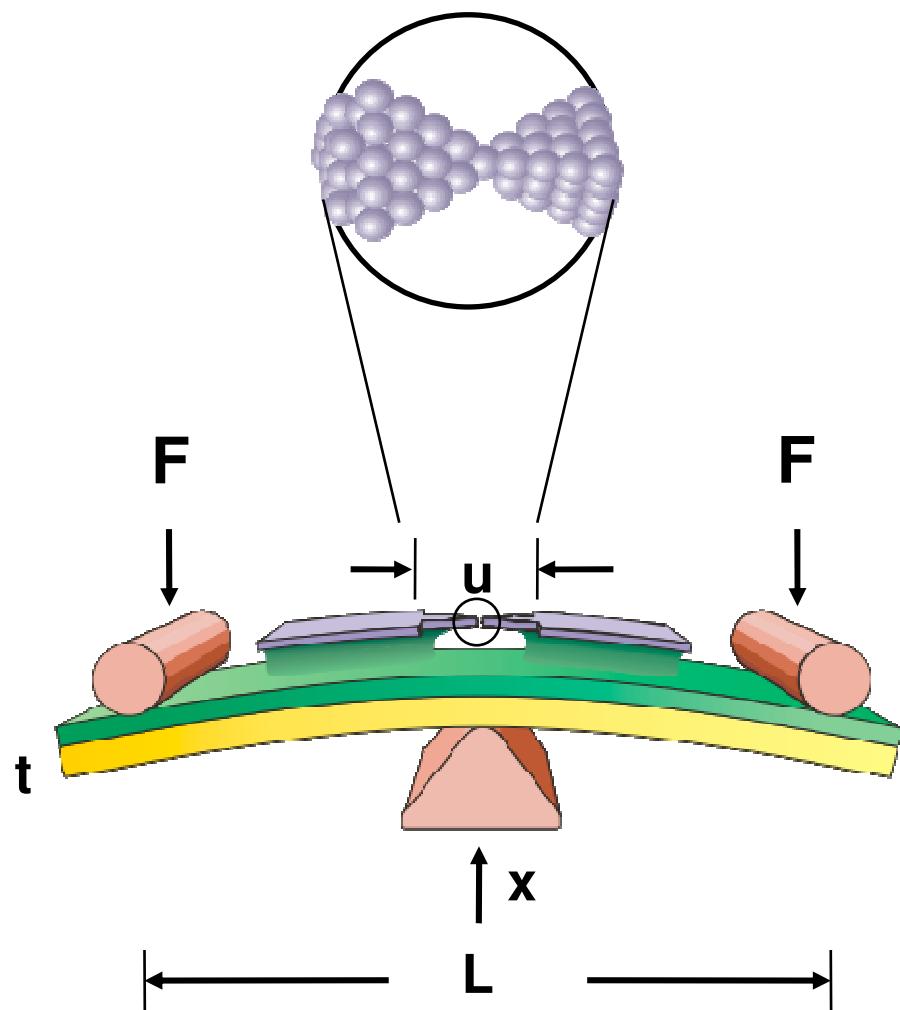
single-level transport  
HOMO: SH, LUMO: CN  
majority carrier  $h^+ / e^-$

Nikolai B Zhitenev<sup>1,3</sup>, Artur Erbe<sup>1,4</sup>, Zhenan Bao<sup>1,5</sup>,  
Weirong Jiang<sup>1,2</sup> and Eric Garfunkel<sup>2</sup>

Nanotechnology **16** (2005) 495–500

A. Erbe et al.  
**small** **2010**, **6**, No. 14, 1529–1535

## Mechanically controlled break junctions

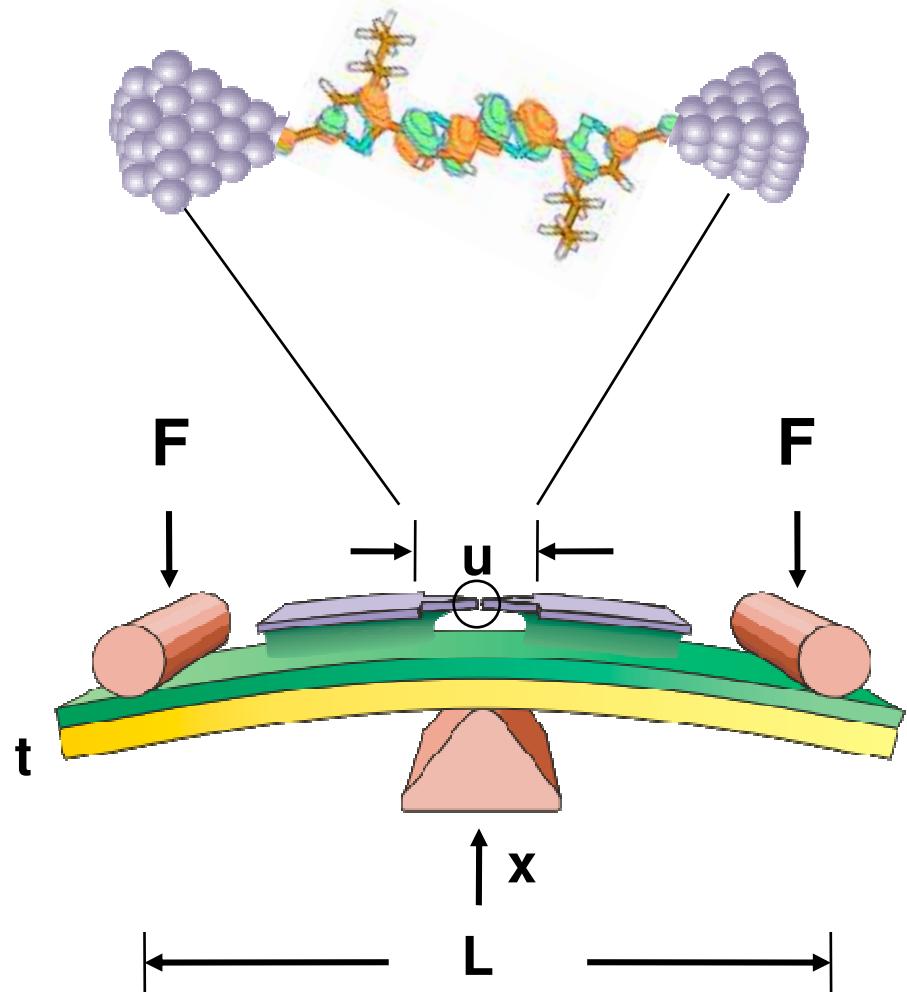


bending by  $\delta x$



lateral stretching:  $\delta u = r \delta x$   
 $(r \sim 10^4 - 10^5)$   
= atomic resolution  
with “simple” mechanics

## Mechanically controlled break junctions



bending by  $\delta x$

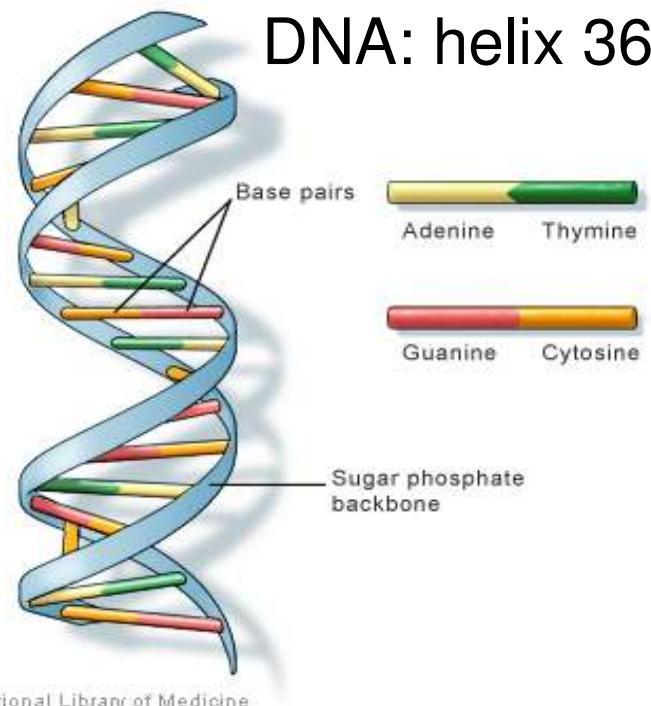


lateral stretching:  $\delta u = r \delta x$   
 $(r \sim 10^4 - 10^5)$   
= atomic resolution  
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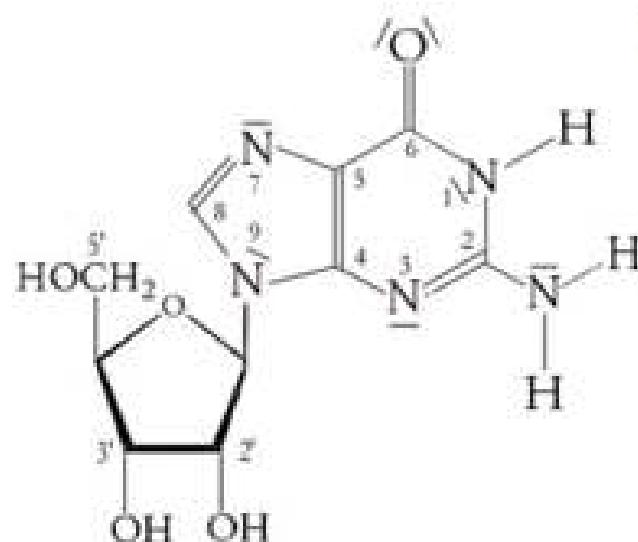
insert molecule  
& measure transport



## Transport through DNA quadruplexes

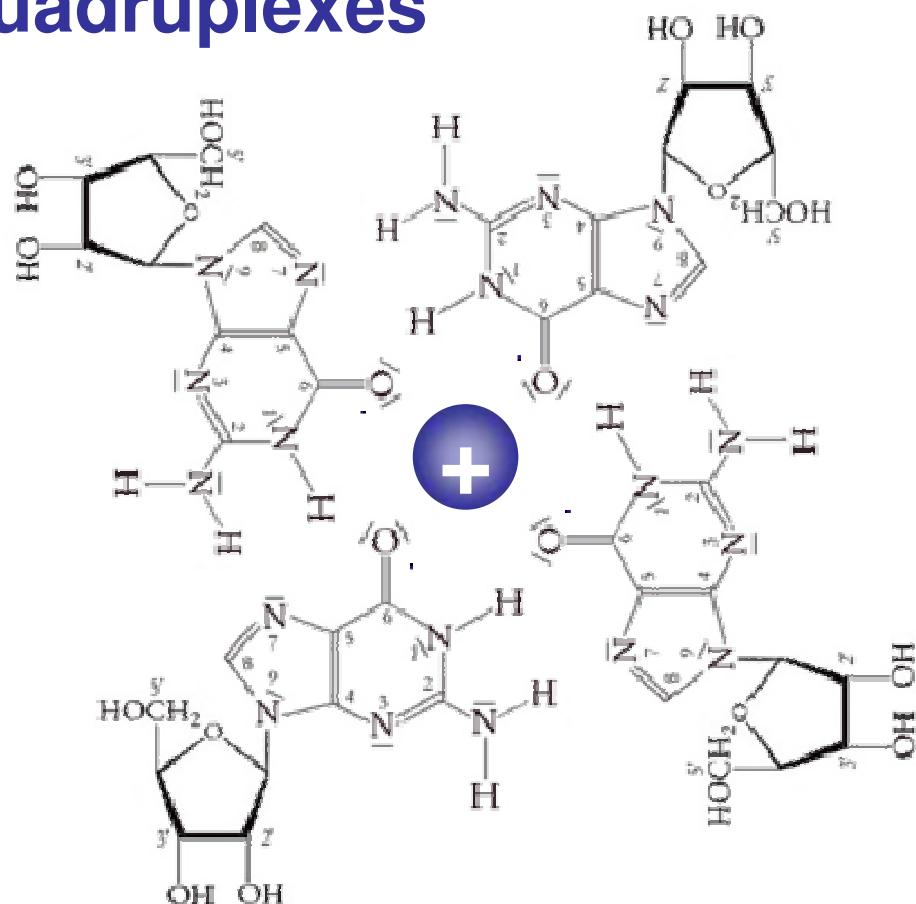
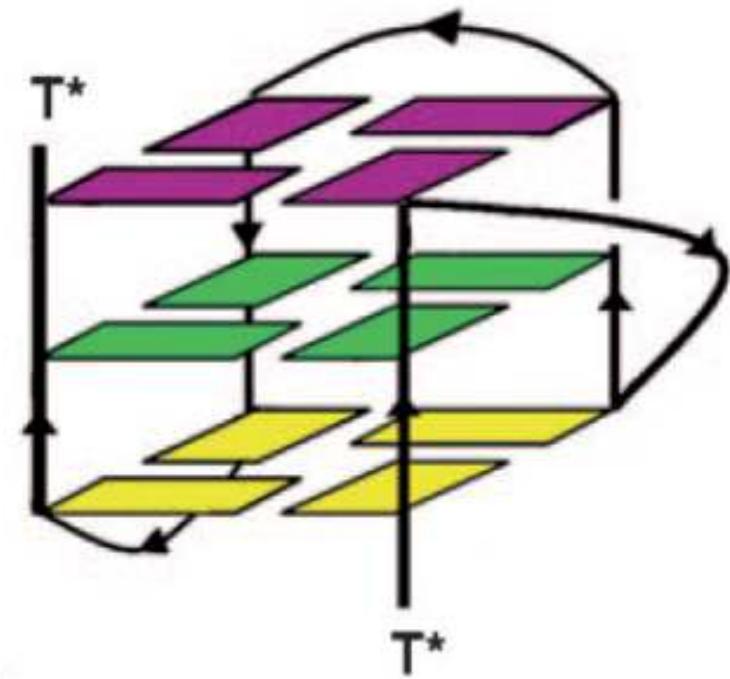


nucleosides:  
G = guanosine



## Transport through DNA quadruplexes

G quadruplex



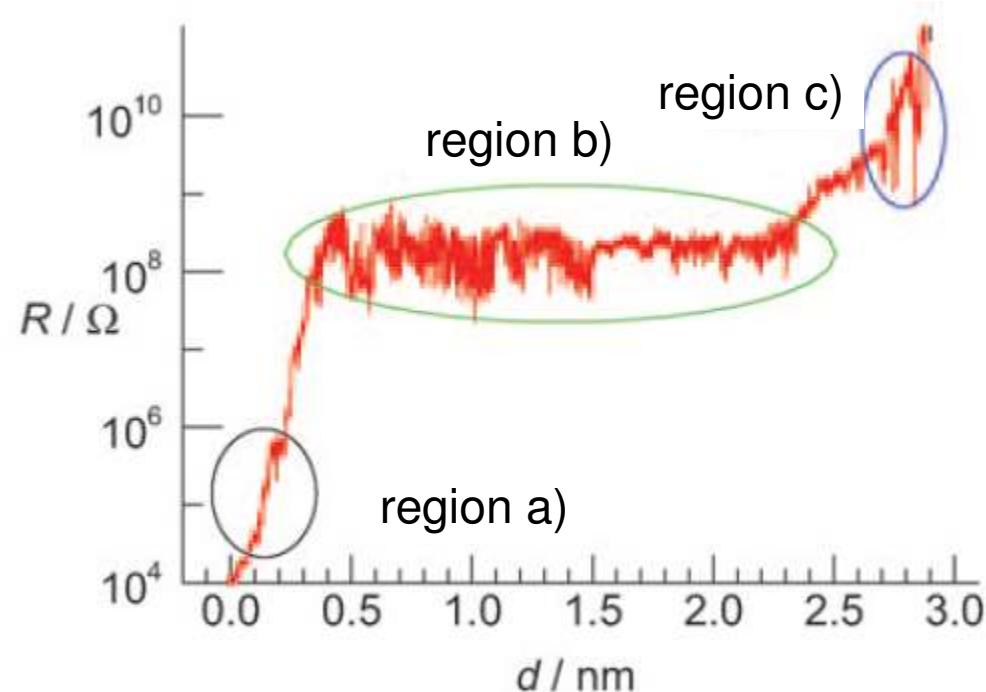
**Angewandte  
Chemie**  
International Edition

**Direct Measurement of Electrical Transport Through G-Quadruplex DNA with Mechanically Controllable Break Junction Electrodes\*\***

*Shou-Peng Liu, Samuel H. Weisbrod, Zhuo Tang, Andreas Marx, Elke Scheer, and Artur Erbe\**

## Transport through DNA quadruplexes

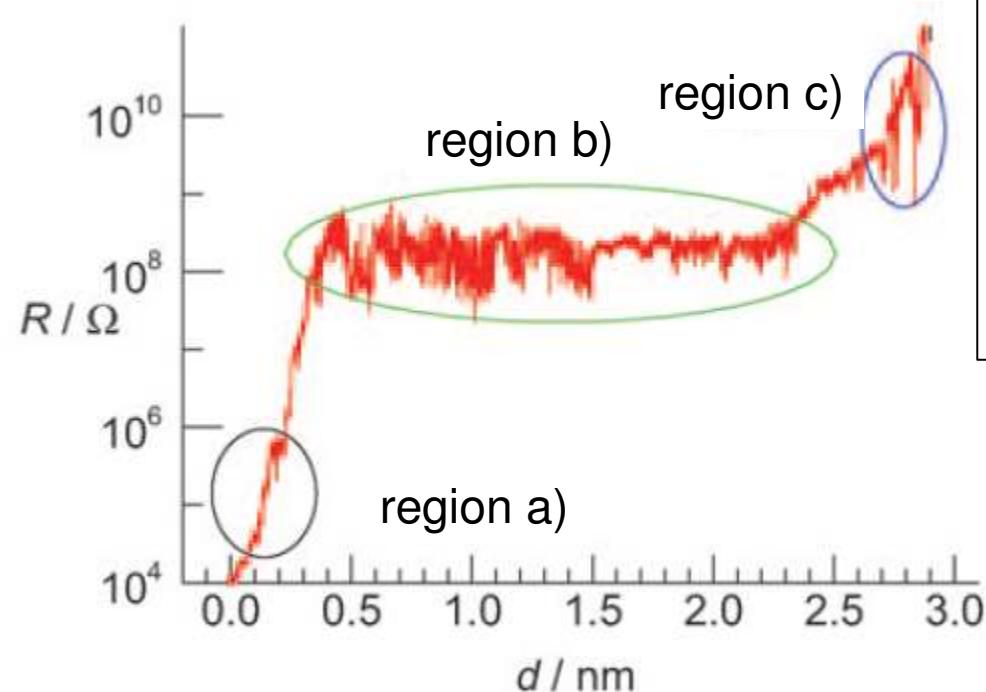
Resistance-distance dependence



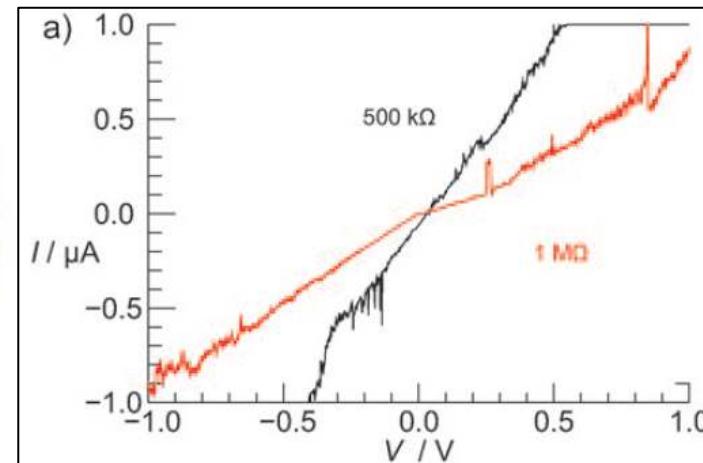
Three stage behaviour?

## Transport through DNA quadruplexes

Resistance-distance dependence

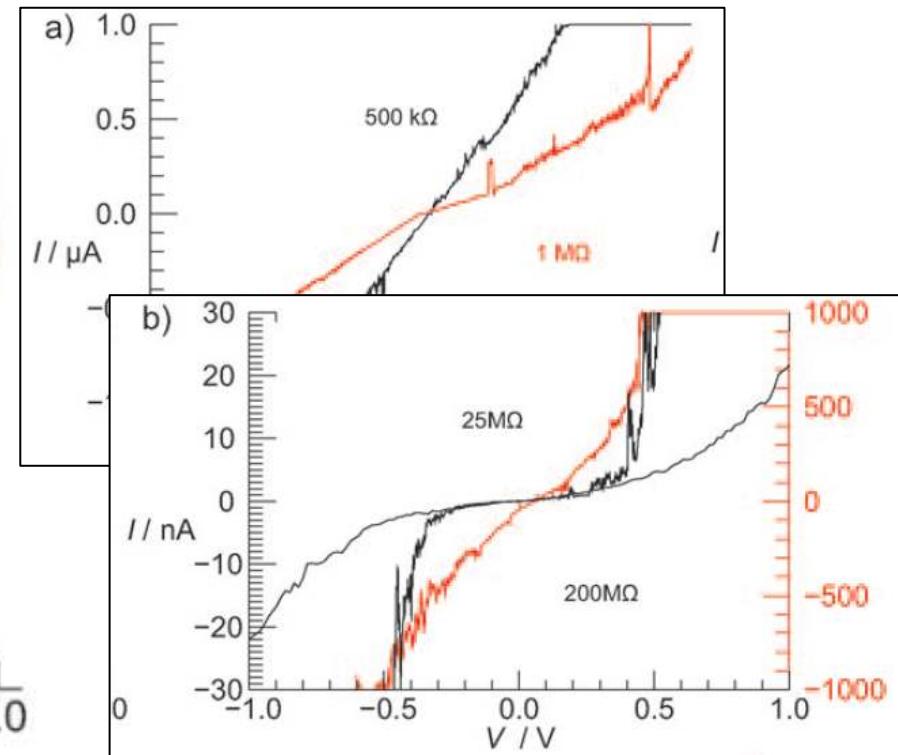
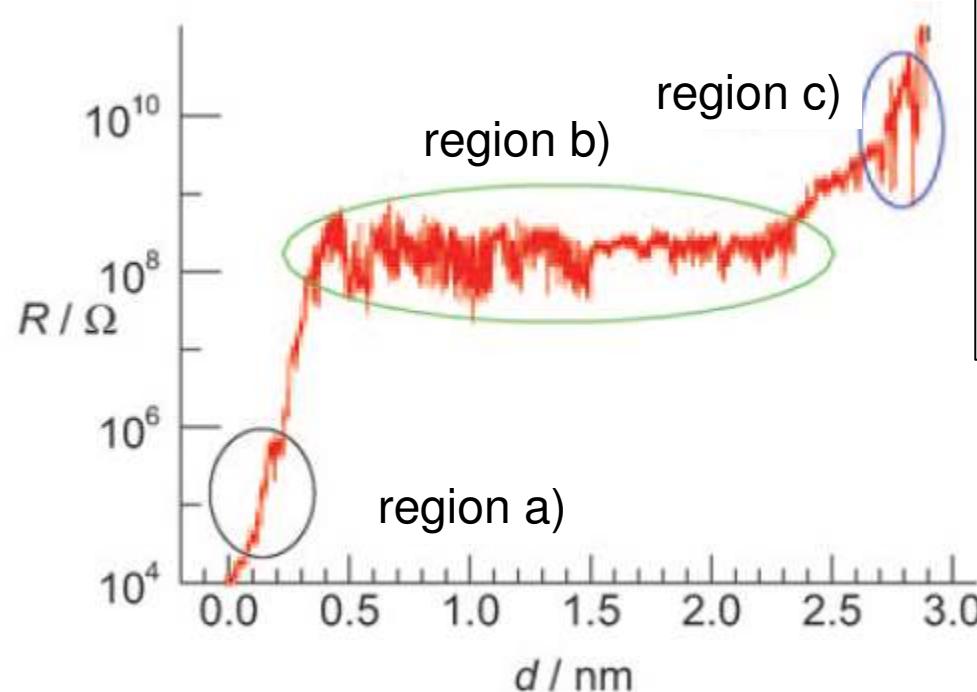


a) direct tunneling electrode-electrode



## Transport through DNA quadruplexes

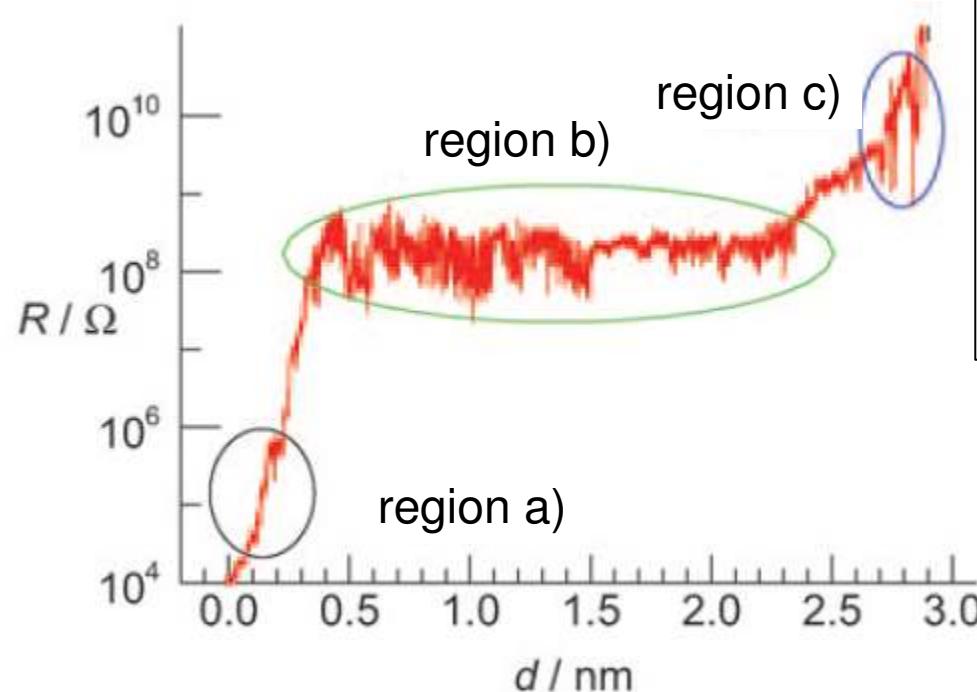
Resistance-distance dependence



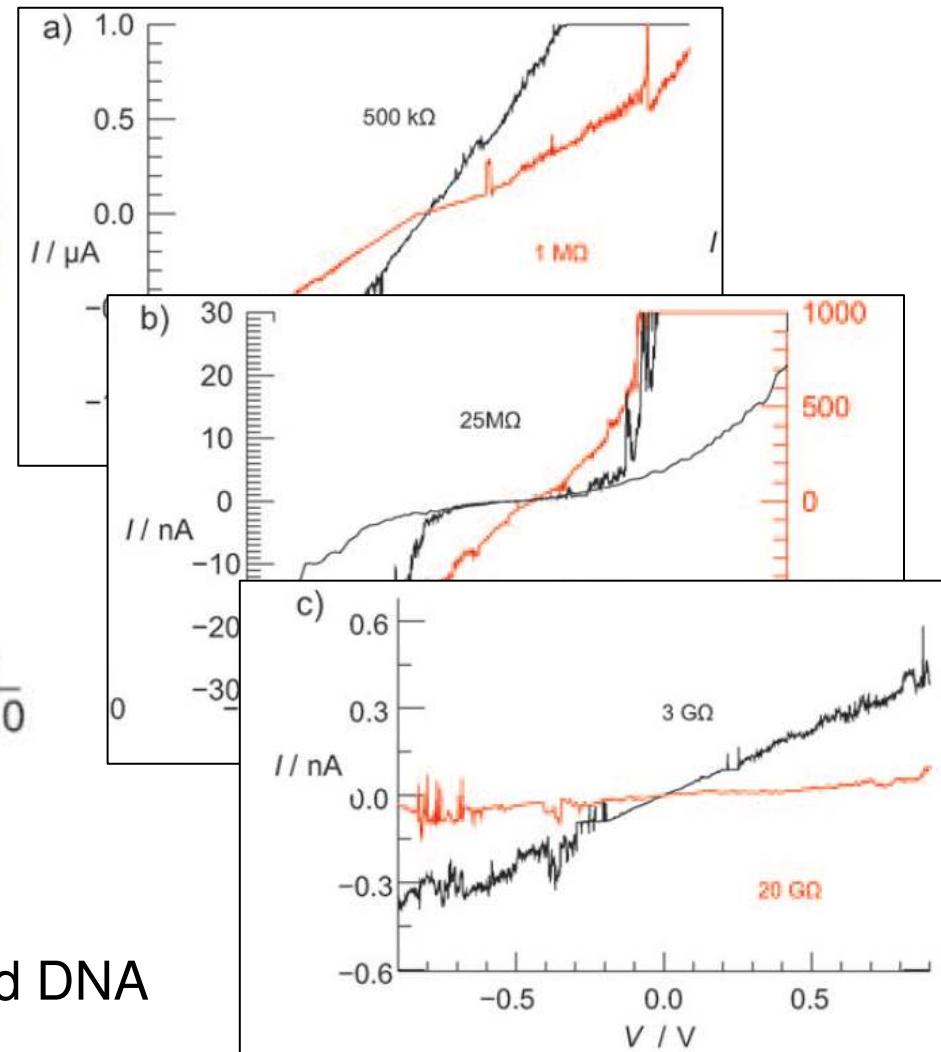
- a) direct tunneling electrode-electrode
- b) quadruplex unfolding

## Transport through DNA quadruplexes

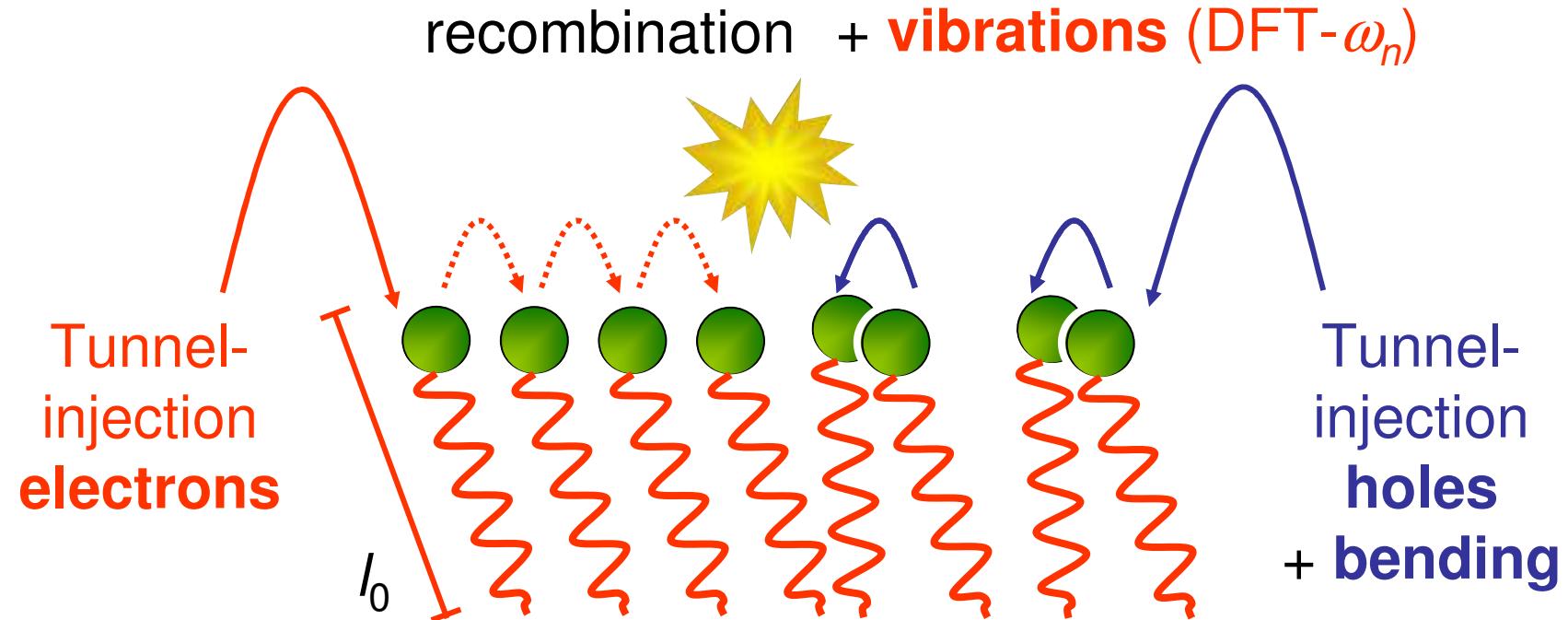
Resistance-distance dependence



- a) direct tunneling electrode-electrode
- b) quadruplex unfolding
- c) tunnel transport through single-strand DNA



## Shuttling transport



continuum elasticity

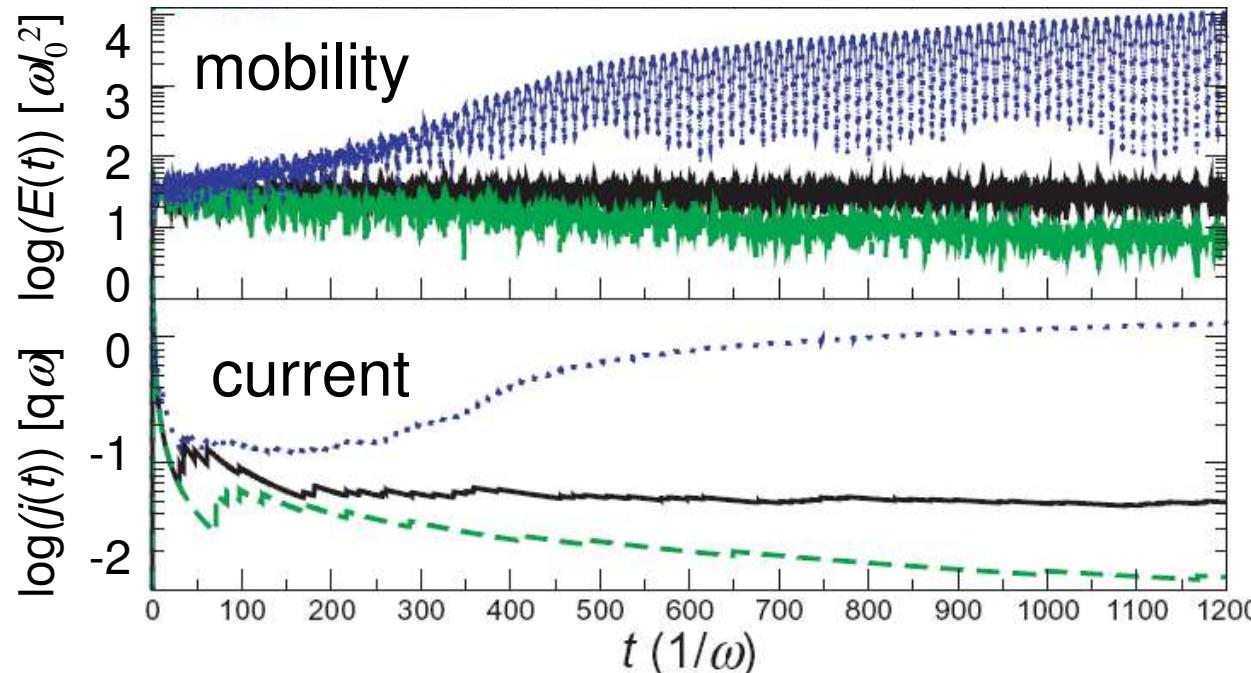
transport equation

$$x_i(t) = \sum_n \phi_{ni} [(c_n \cos \omega_n t + d_n \sin \omega_n t) + \int_0^t dt' ((\sin \omega_n (t-t') / \omega_n) \sum_m a_m(t') \phi_{nm})]$$

$$q_{i,\text{nee}} = q_{i,\text{old}} + \Delta q_{i,\text{trans}} + \Delta q_{i,\text{tunn}} - \Delta q_{i,\text{rec}}$$

(normal basis:  $\phi_{ni}$ )

## Shuttling transport – diode effect



bias voltage

-0.2 V =  $\uparrow\downarrow$  bending  
no current

0.0 V = little current

0.2 V =  $\uparrow\uparrow$  bending  
high current

## New Journal of Physics

The open-access journal for physics

Current without external bias and diode effect  
in shuttling transport of nanoshfts

K Morawetz<sup>1,2,3</sup>, S Gemming<sup>1</sup>, R Lushtinetz<sup>4</sup>, L M Eng<sup>5</sup>,  
G Seifert<sup>4</sup> and A Kenfack<sup>2</sup>

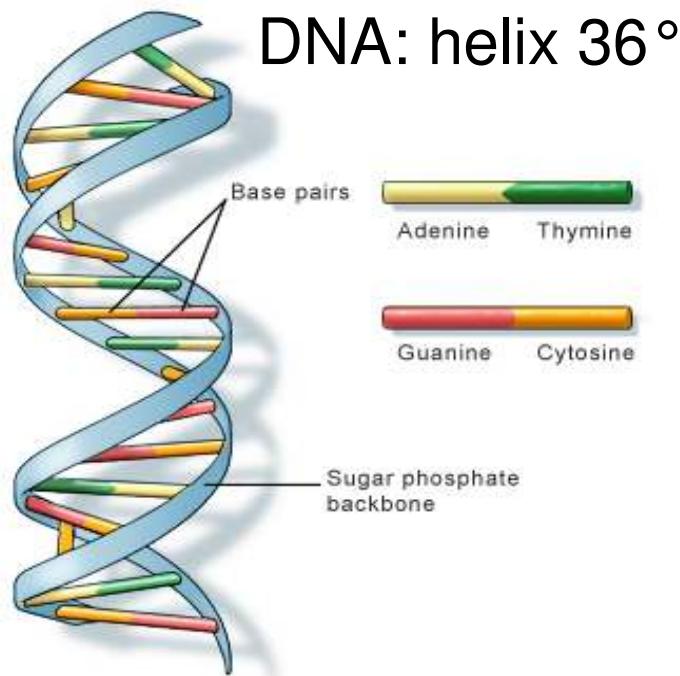
current without bias  
diode effect  
dissipative effects  
assist or counteract

# Continuous wire/tube gate

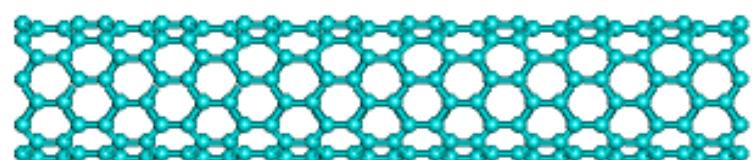
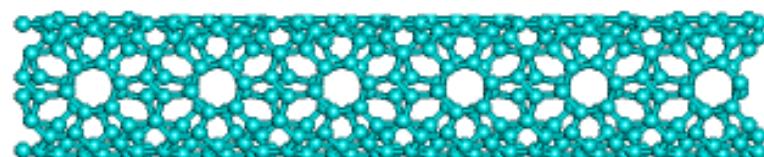
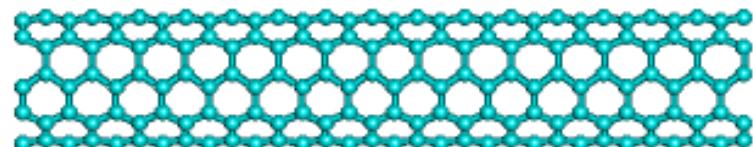
## CNT@DNA

### $(\text{Mo}_6\text{S}_6)_\infty$

## CNT@DNA as Gate?



CNT – Winkel ~ Chiralität

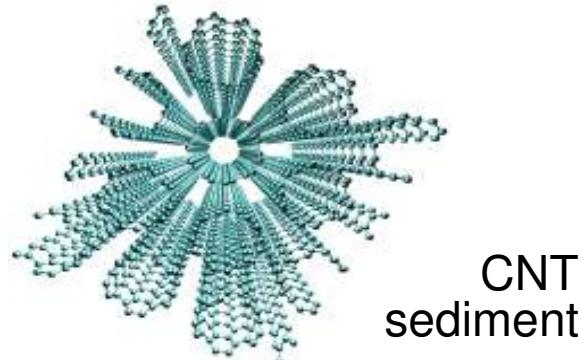


## DNA-wrapped carbon nanotubes

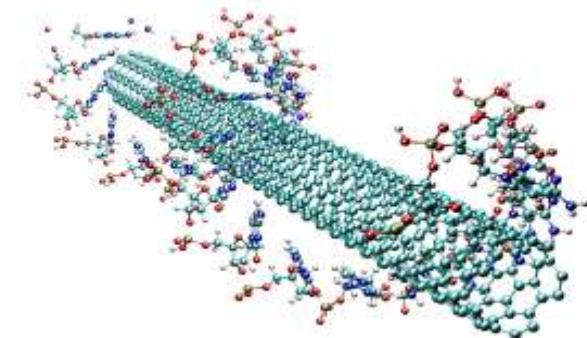
A N Enyashin<sup>1,2</sup>, S Gemming<sup>3</sup> and G Seifert<sup>1</sup>

## Formation energy of CNT@DNA aggregates

$E_{coh}$  – cohesion of CNT bundles



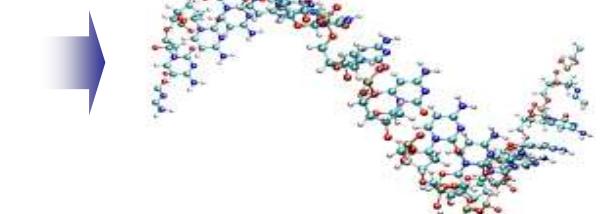
$E_{ads}$  – adsorption  
DNA – base  
on CNT



$E_{def}$  – Deformation des DNA Strangs



ss-DNA molecule



distorted ss-DNA

$\Delta E_f$  – formation  
energy

## Classical interaction model

first-principles  
(DFT, HF-MP2)

$E_{\text{coh}}$ ,  $E_{\text{def}}$ ,  $E_{\text{int}}$



$$\Delta E_f = E_{\text{coh}} + N E_{\text{def}} + N_{\text{base}} E_{\text{int}}$$

analytic form

$$E_{\text{coh}} = a \sqrt{R_{\text{CNT}}}$$

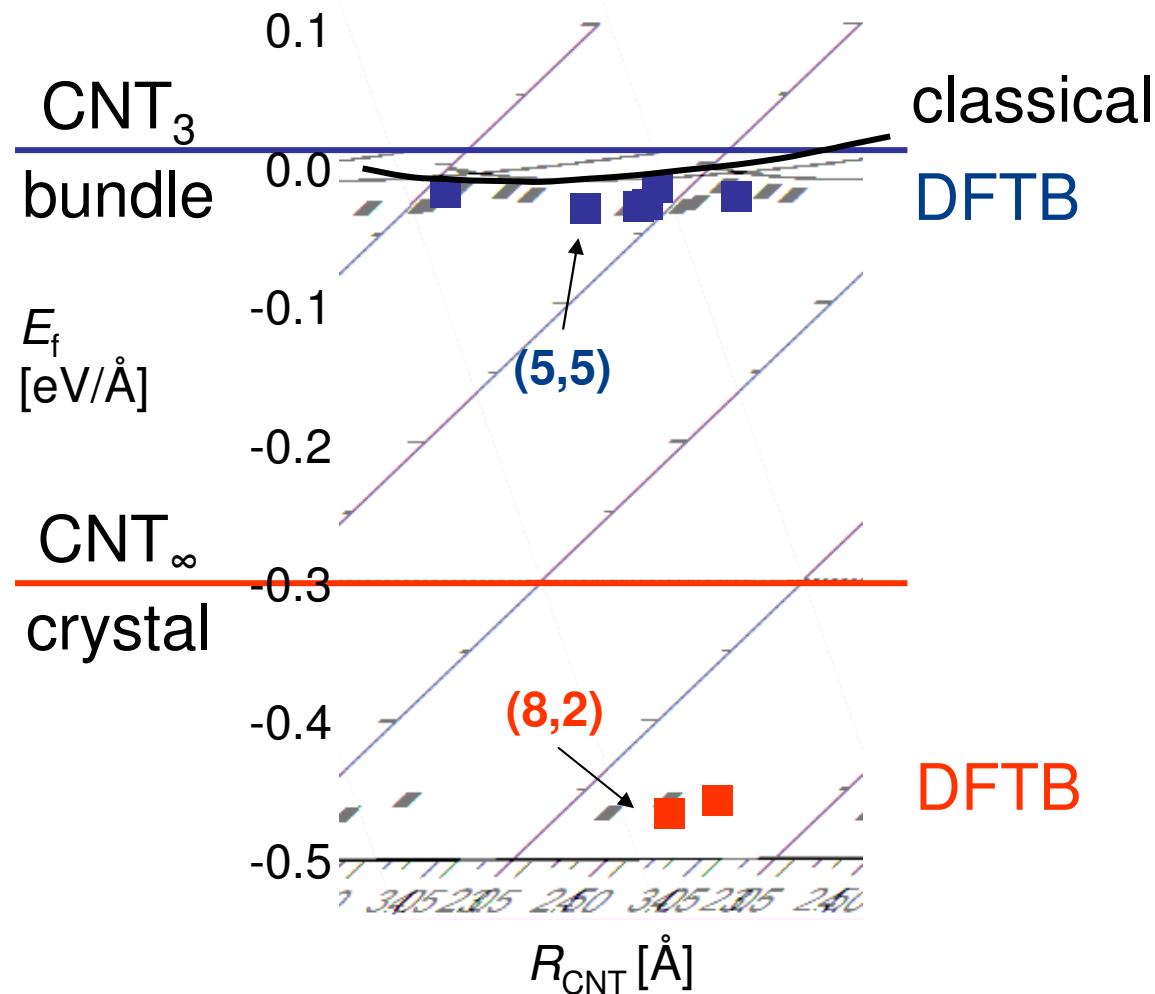
( $N_{\text{base}}$ : number of bases)

$$E_{\text{def}} = a + b/(R_{\text{DNA}})^3 + c R_{\text{DNA}} + d R_{\text{DNA}}^2$$

$$R_{\text{DNA}} = R_{\text{CNT}} + I_{\text{vdW}} + I_{\text{C-N}}$$

( $R$ : radius,  $N$ : number of DNA strands)

## Validation vs. quantum mechanics: DFTB/disp

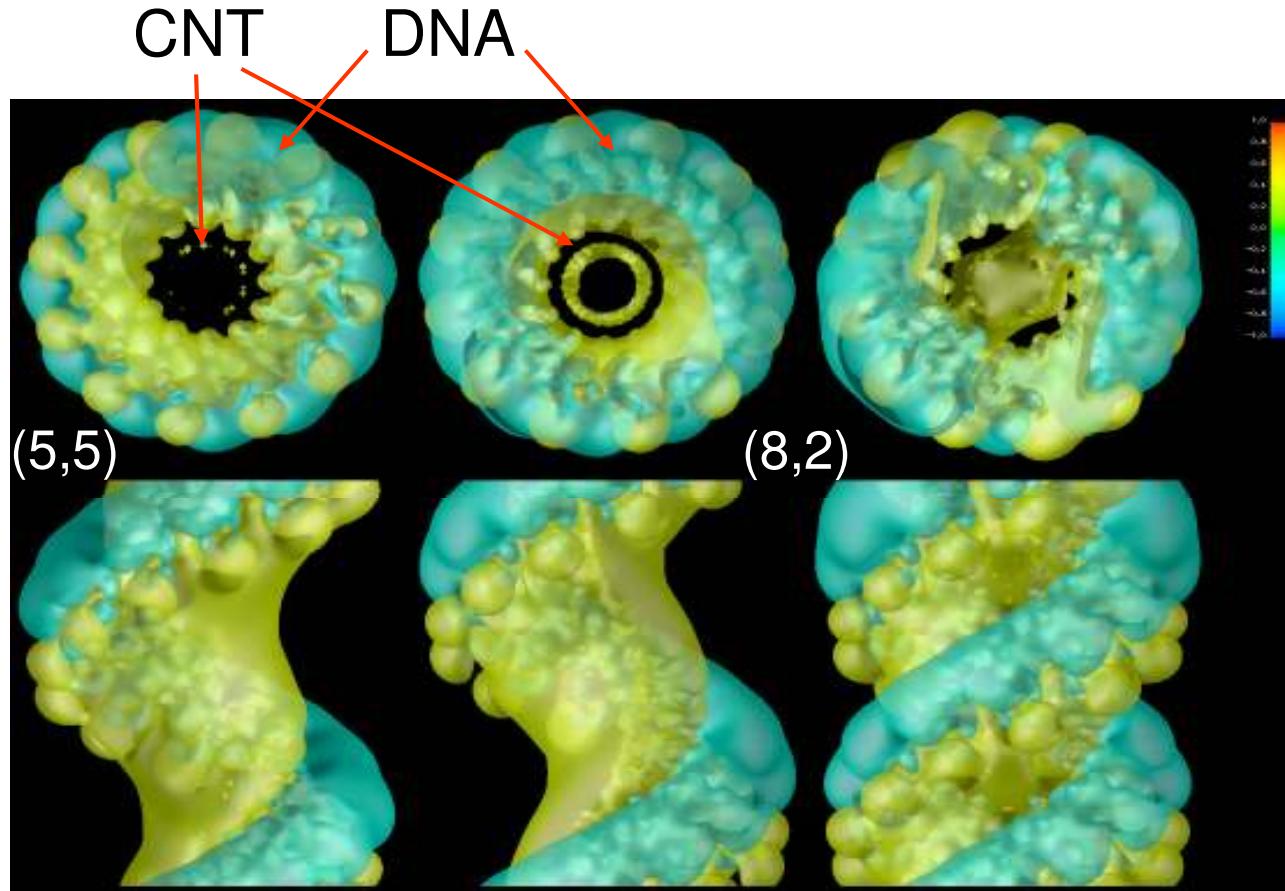


most cases  
classical = QM

preferably  
from CNT bundles  
(sonicate!)

metallic & chiral CNT  
stronger interaction

## DF-TB – Charge transfer in CNT@DNA



electrostatic field: +0.4 e/Å (y) and -0.4 e/Å (b)

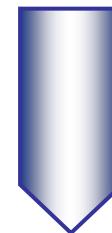
electron transfer

(5,5) @ poly-C: -0.005

(8,2) @ poly-C: -0.374

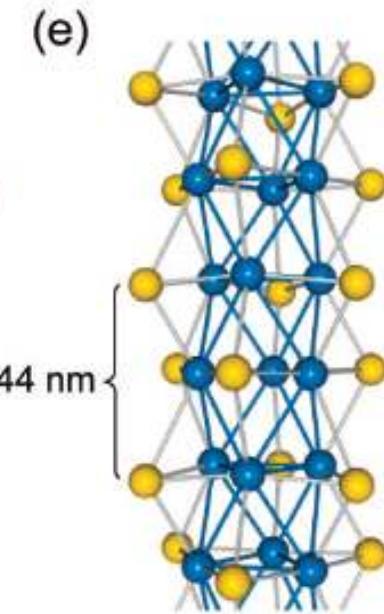
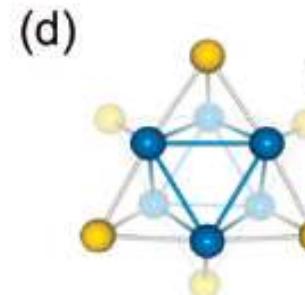
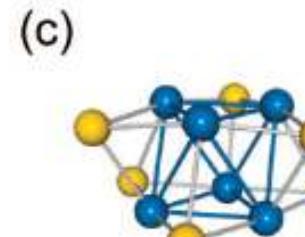
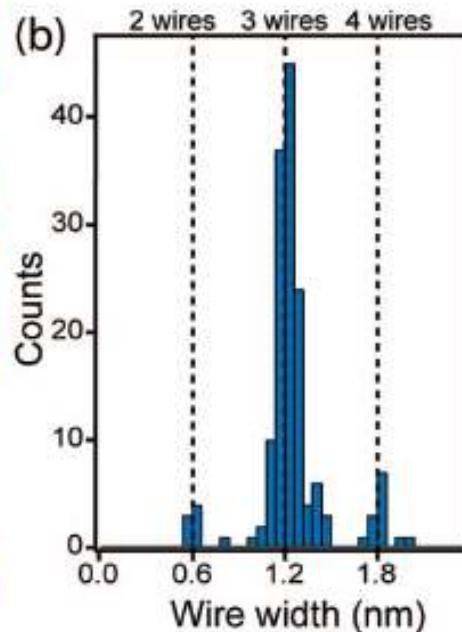
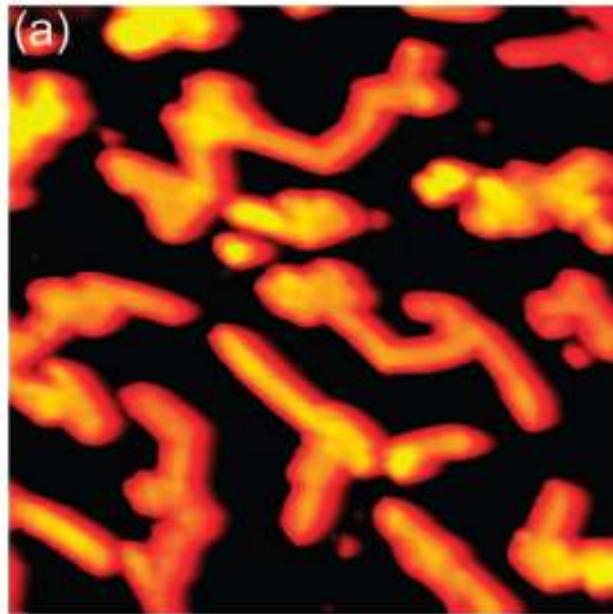
2 poly-C: -0.825

(7,4) @ poly-C: -0.237



polar,  
resonant transfer  
ballistic transport

## MoS<sub>2</sub> – based nanowires: S-deficient Mo<sub>6</sub>S<sub>6</sub>



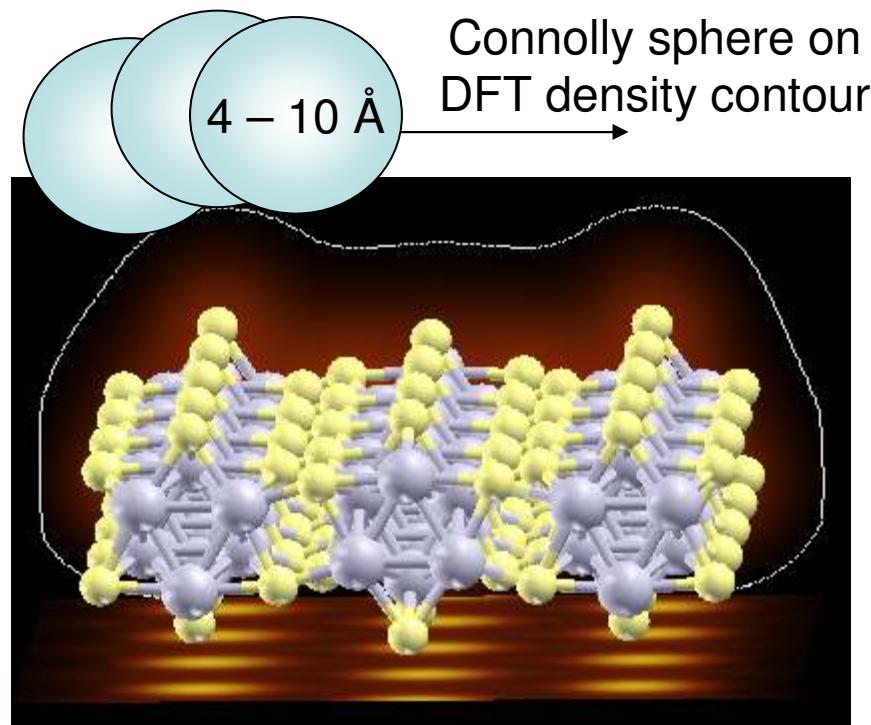
## Atomic-Scale Structure of Mo<sub>6</sub>S<sub>6</sub> Nanowires

Jakob Kibsgaard,<sup>†</sup> Anders Tuxen,<sup>†</sup> Martin Levisen,<sup>†</sup> Erik Lægsgaard,<sup>†</sup> Sibylle Gemming,<sup>‡</sup> Gotthard Seifert,<sup>§</sup> Jeppe V. Lauritsen,<sup>\*,†</sup> and Flemming Besenbacher<sup>\*,†</sup>

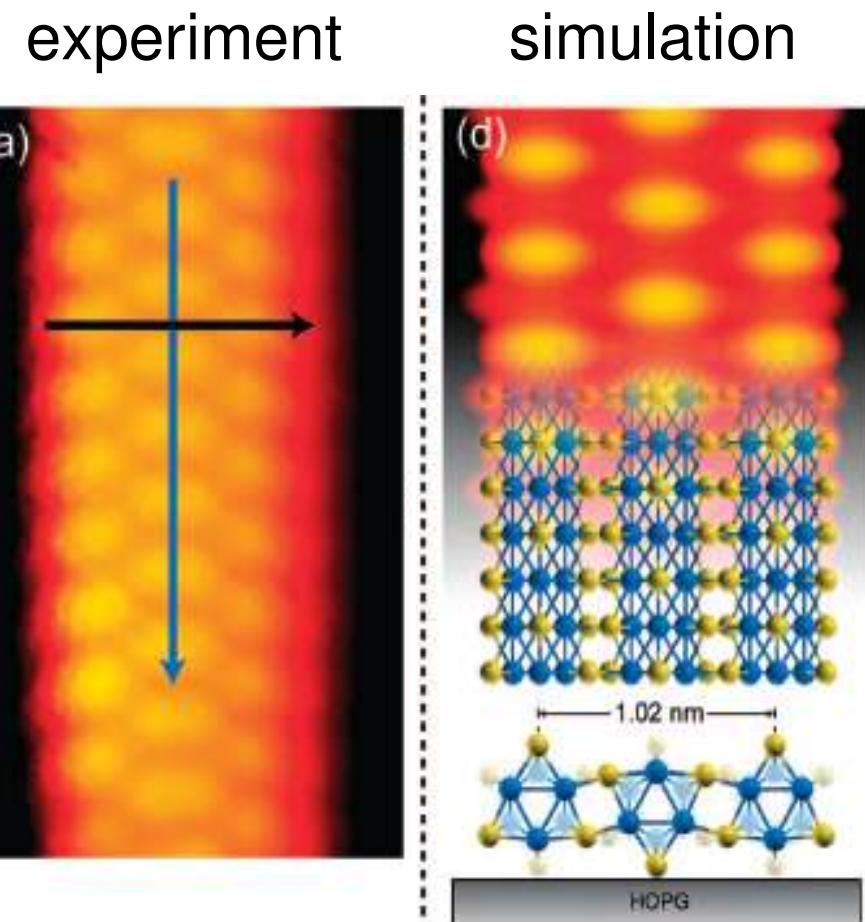
NANO  
LETTERS

(*Nano Lett.* **8** (2008) 3928-3931)

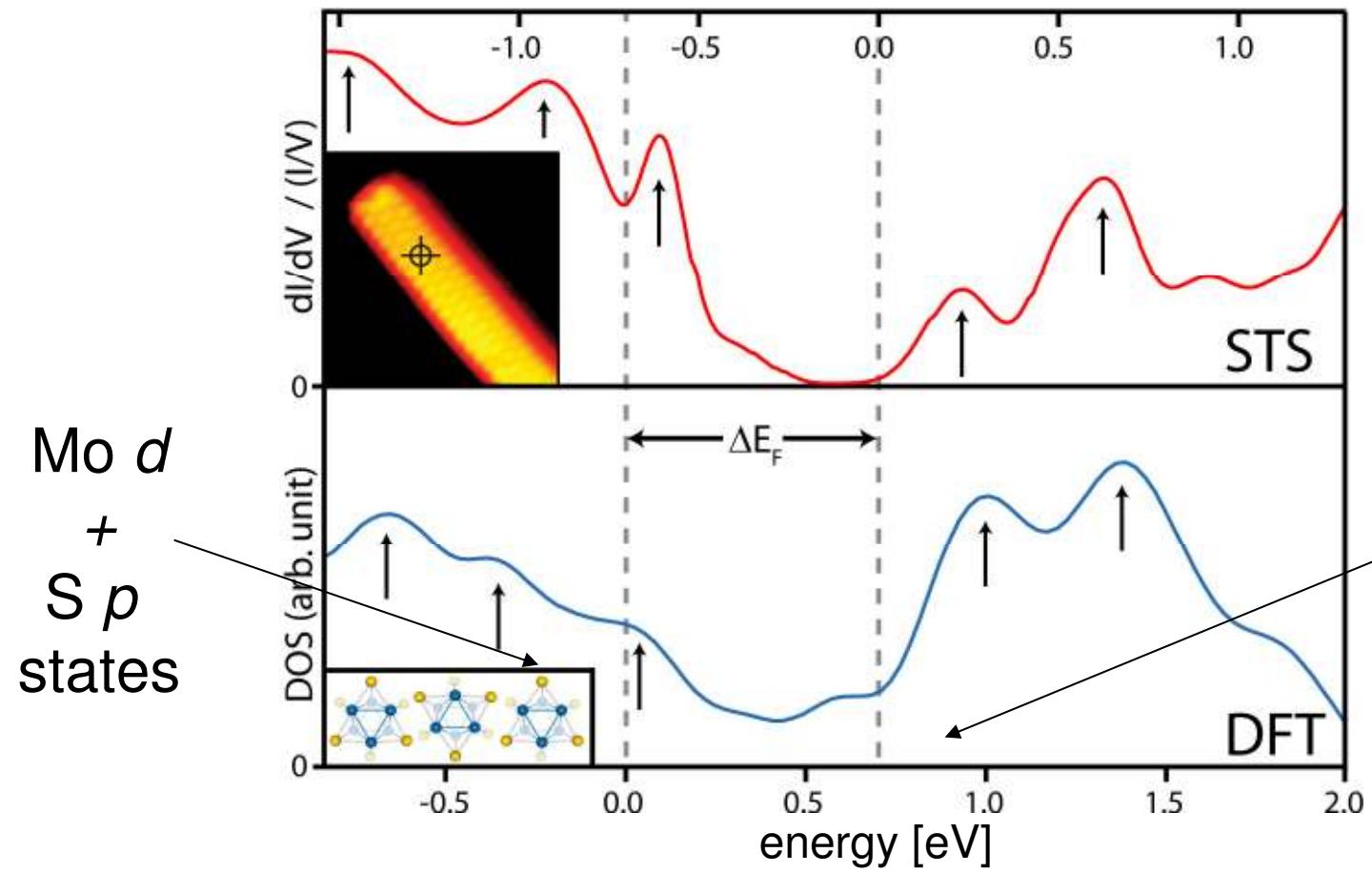
## Mo<sub>6</sub>S<sub>6</sub> nanowires: STM - structure



maxima at S  
distances **4.4 Å**, 10.2 Å  
wire height 9.4( $\pm 0.1$ )Å



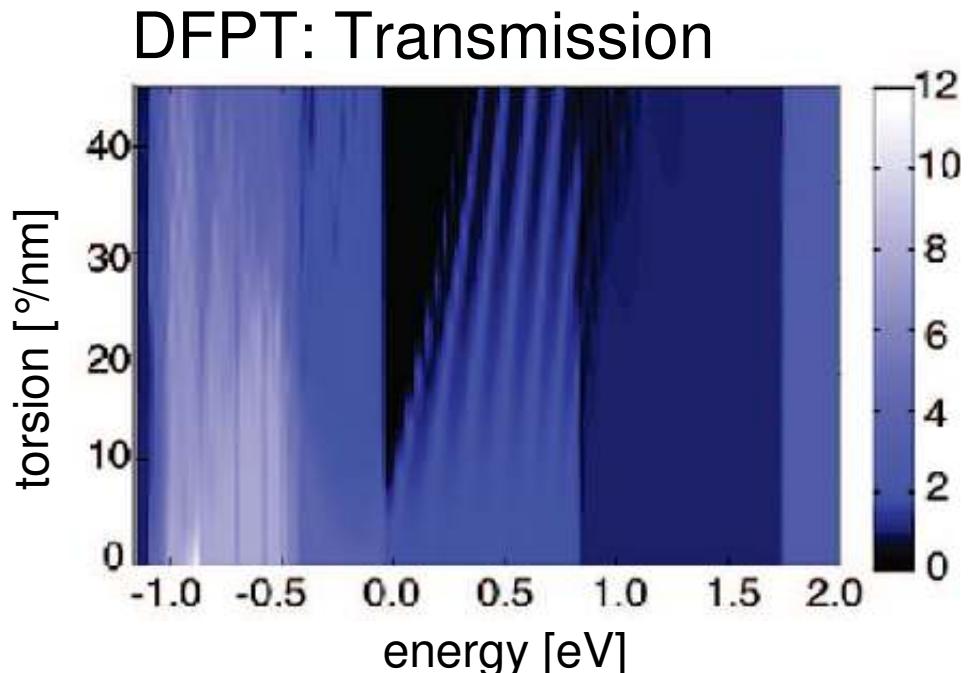
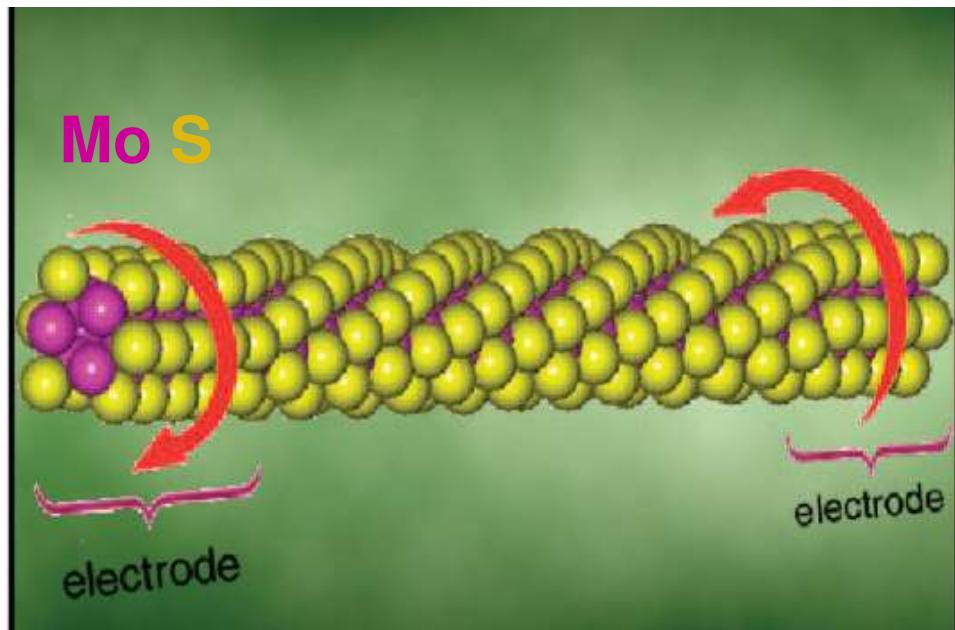
## $\text{Mo}_6\text{S}_6$ nanowires: STS - conductivity



$\text{Mo } d$   
 states  
 $=$   
 conduction  
 band edge  
  
 Besenbacher  
 (Aarhus)

metallic conductance through Mo part, S insulates

## $\text{Mo}_6\text{S}_6$ : Electromechanic switch



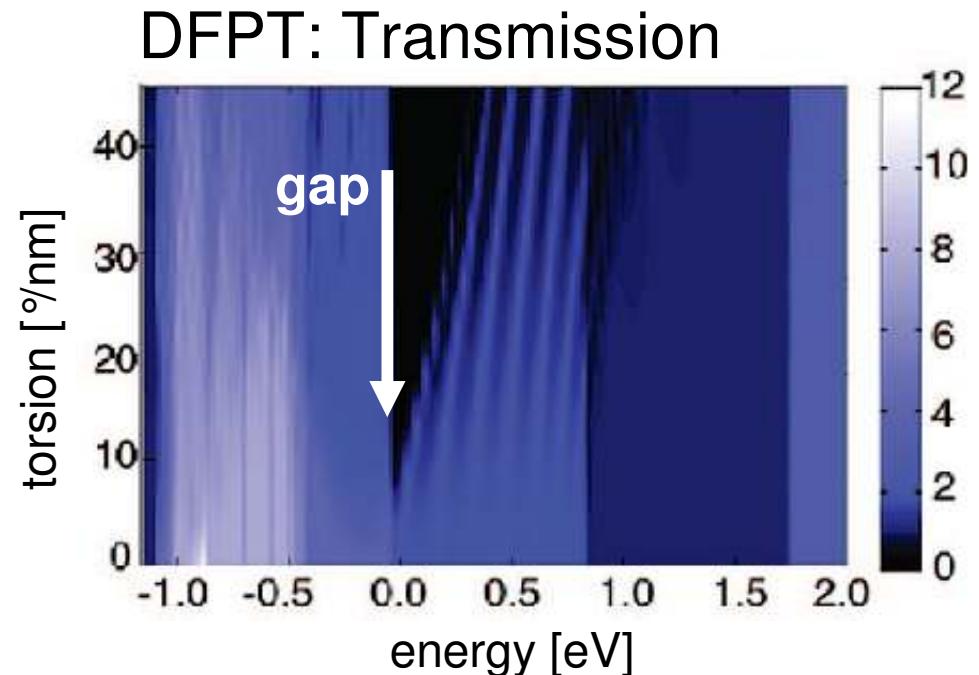
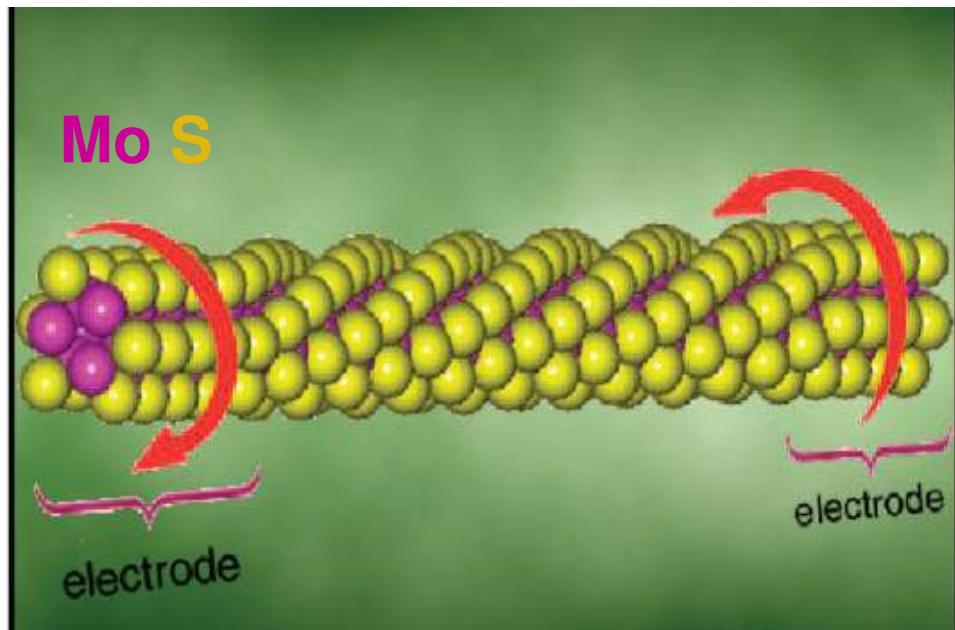
## Electromechanical Switch Based on $\text{Mo}_6\text{S}_6$ Nanowires

Igor Popov,<sup>\*,†</sup> Sibylle Gemming,<sup>‡</sup> Shinya Okano,<sup>†</sup> Nitesh Ranjan,<sup>§</sup>  
and Gotthard Seifert<sup>†</sup>

NANO  
LETTERS

(*Nano Lett.* **8** (2008) 4093-4097)

## $\text{Mo}_6\text{S}_6$ : Electromechanic switch



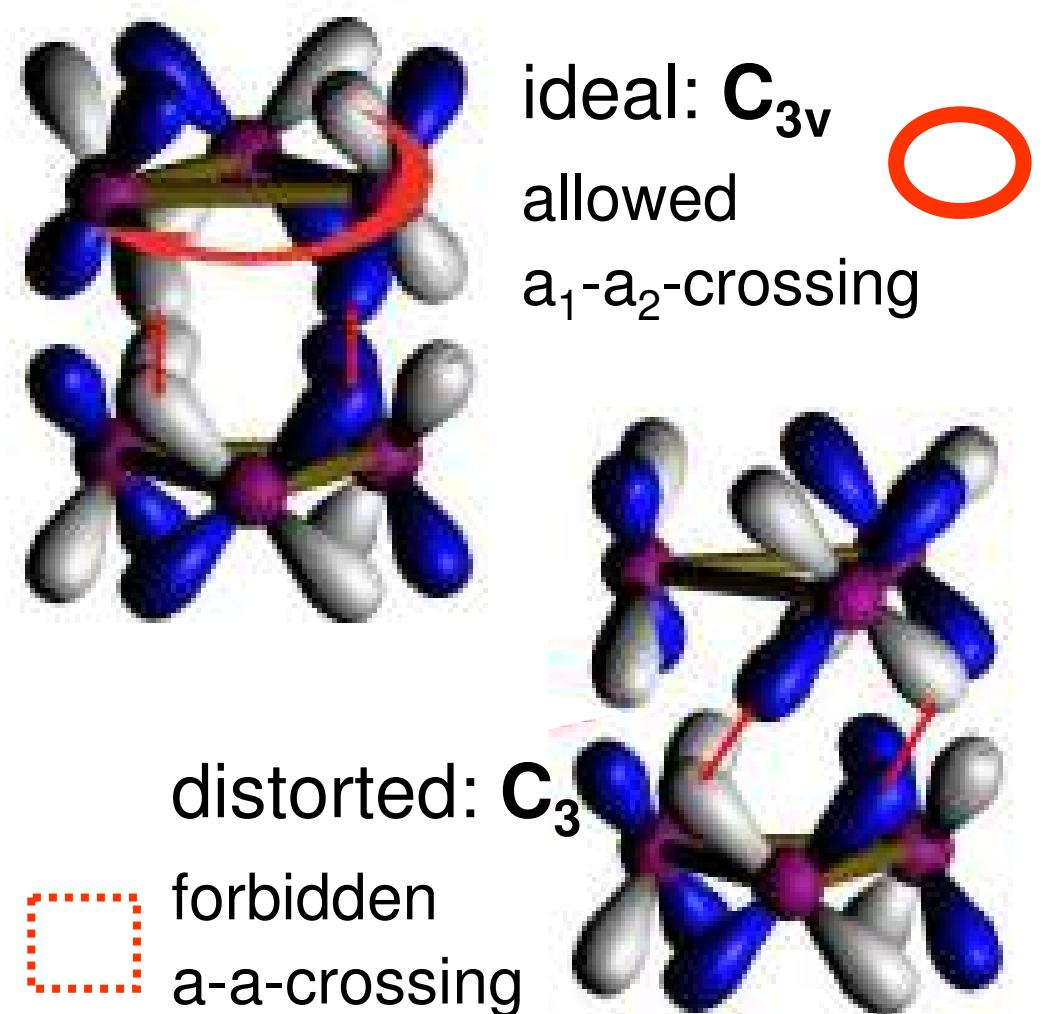
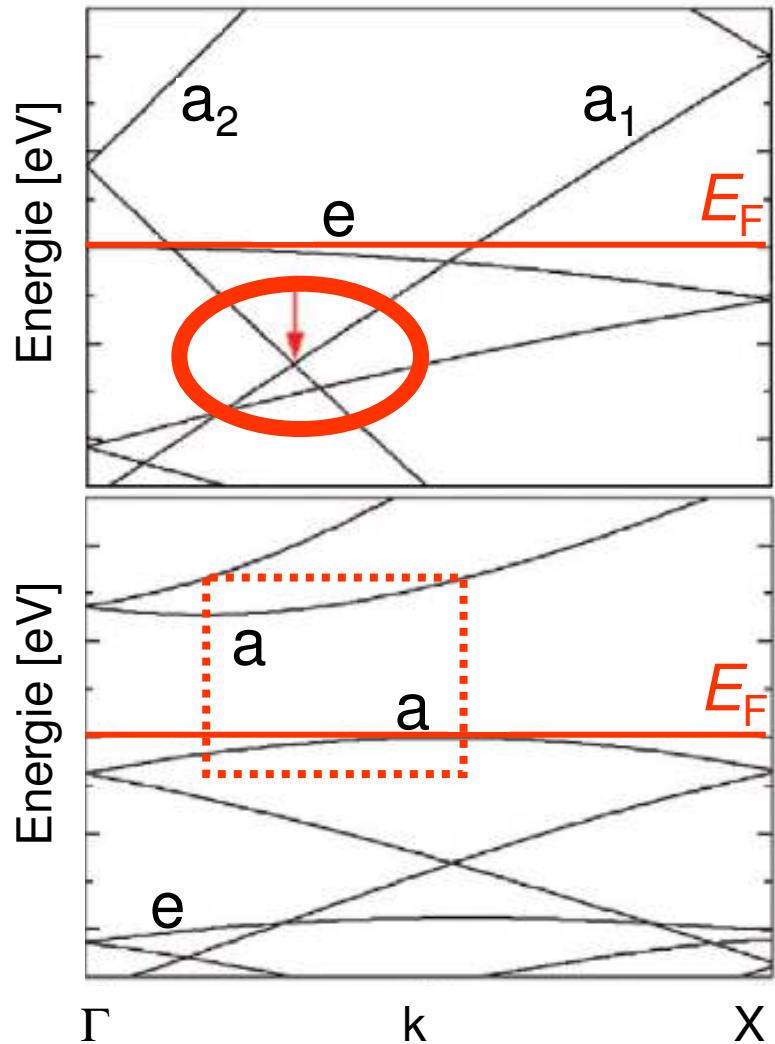
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## $\text{Mo}_6\text{S}_6$ : Structure-induced metal-insulator transition!



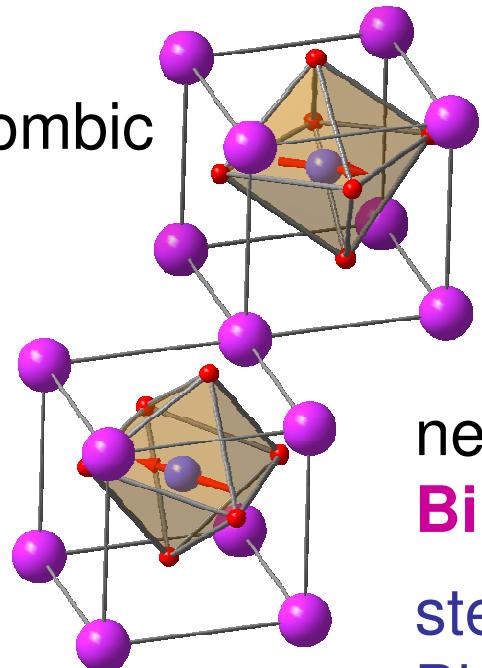
# Switching – Electrostatic field on interfaces

Domain walls in BiFeO<sub>3</sub>

# Electrostatic field at domain boundaries

**BiFeO<sub>3</sub>**

orthorhombic  
unit cell



tilted  
**FeO<sub>6</sub>**  
octahedra

near-cubic  
**Bi** arrangement  
stereoactive  
Bi lone pair

nature  
materials

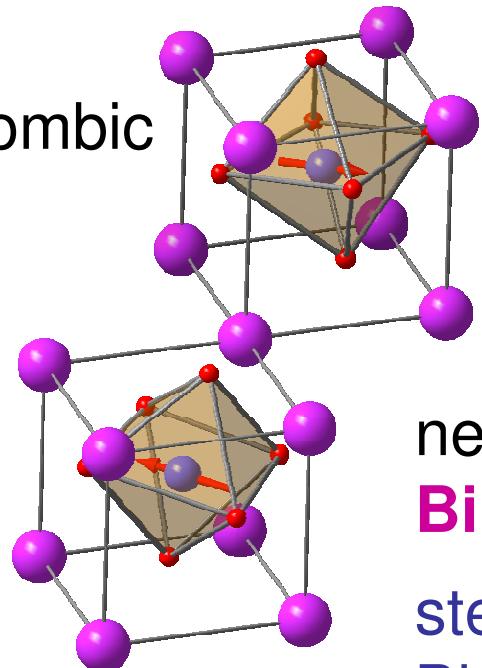
## Conduction at domain walls in oxide multiferroics

J. Seidel<sup>1,2\*</sup>, L. W. Martin<sup>2,3\*</sup>, Q. He<sup>1</sup>, Q. Zhan<sup>2</sup>, Y.-H. Chu<sup>2,3,4</sup>, A. Rother<sup>5</sup>, M. E. Hawkridge<sup>2</sup>, P. Maksymovych<sup>6</sup>, P. Yu<sup>1</sup>, M. Gajek<sup>1</sup>, N. Balke<sup>1</sup>, S. V. Kalinin<sup>6</sup>, S. Gemming<sup>7</sup>, F. Wang<sup>1</sup>, G. Catalan<sup>8</sup>, J. F. Scott<sup>8</sup>, N. A. Spaldin<sup>9</sup>, J. Orenstein<sup>1,2</sup> and R. Ramesh<sup>1,2,3</sup>

# Electrostatic field at domain boundaries

**BiFeO<sub>3</sub>**

orthorhombic  
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near-cubic  
**Bi** arrangement  
stereoactive  
Bi lone pair

§ antiferromagnet

$$T_N \sim 650 \text{ K}$$

§ rhombohedral ferroelectric

$$T_C \sim 1103 \text{ K}$$

§ spontaneous polarization

$$P \sim 90 \text{ C cm}^{-2}$$

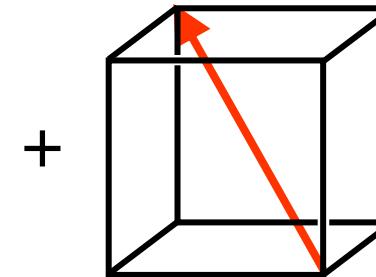
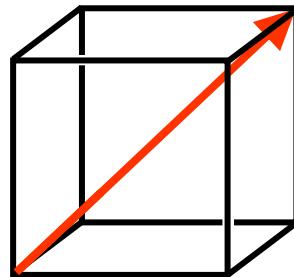
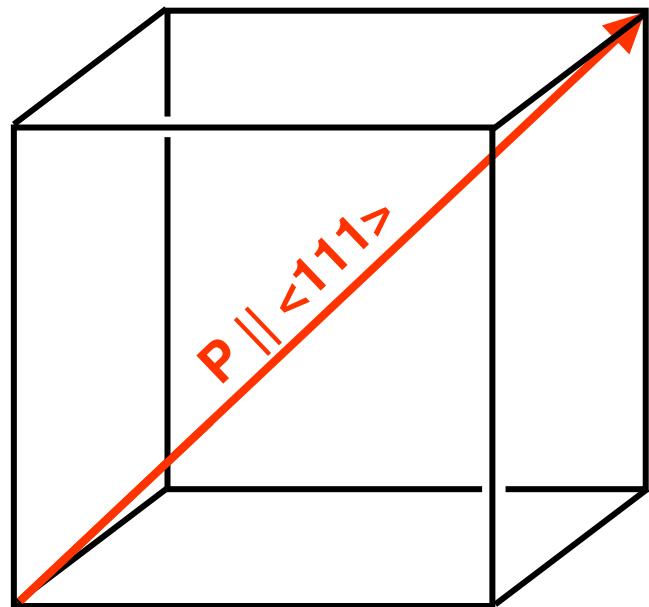
along pseudocubic <111>

nature  
materials

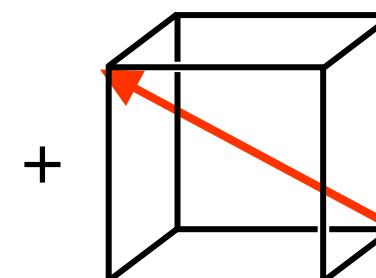
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# Relative domain orientations

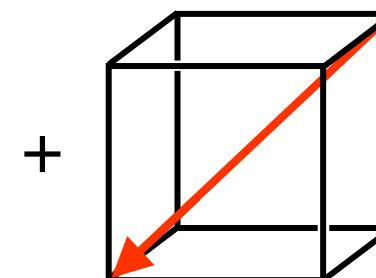
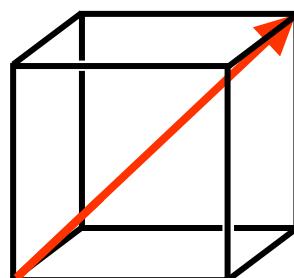


71° wall



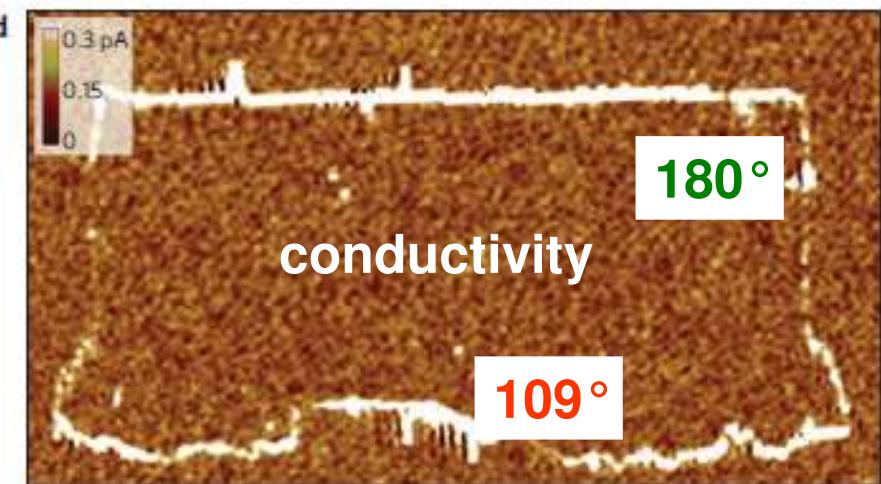
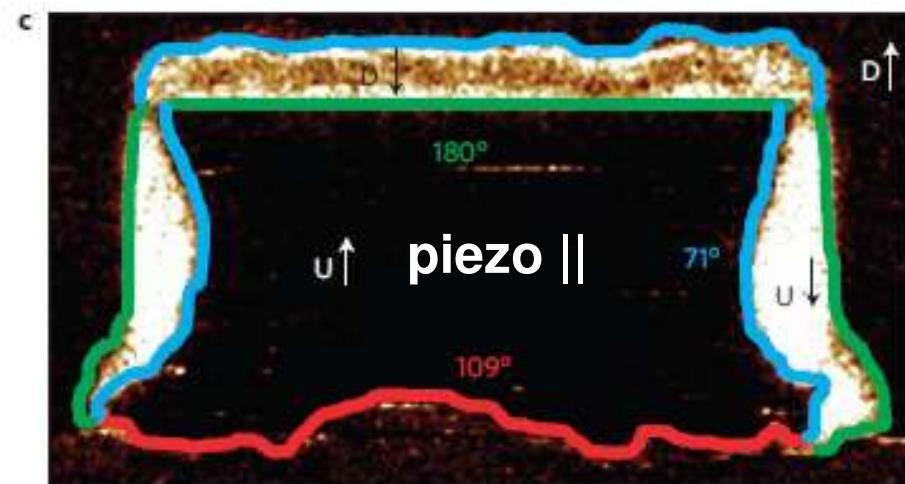
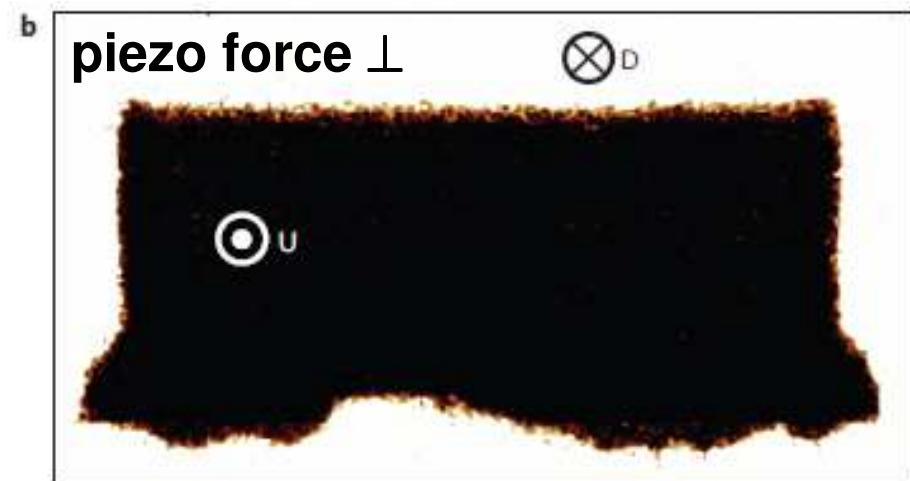
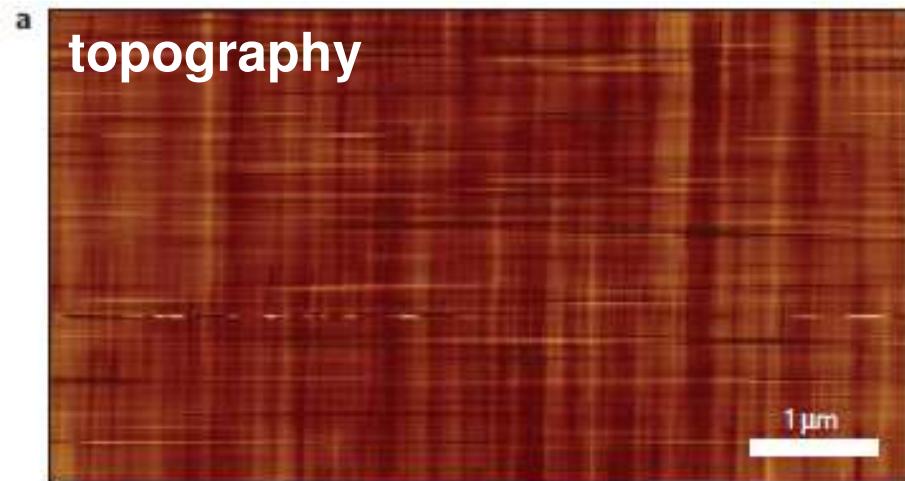
109° wall

ferroelectric  
polarization  
 $P \parallel <111>$



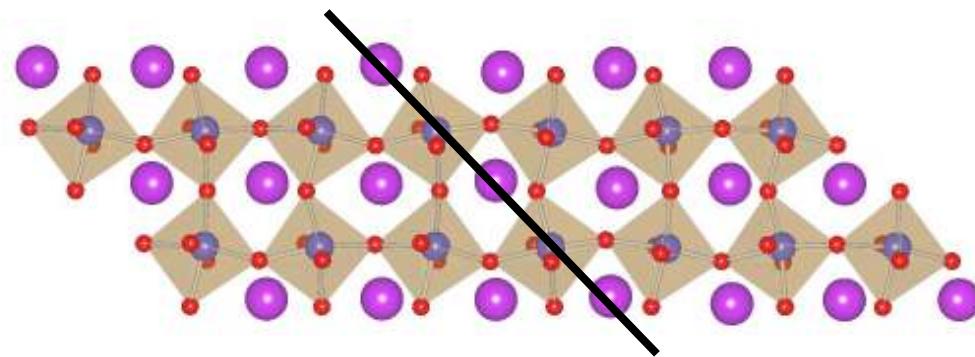
180° wall

# Observed domain walls

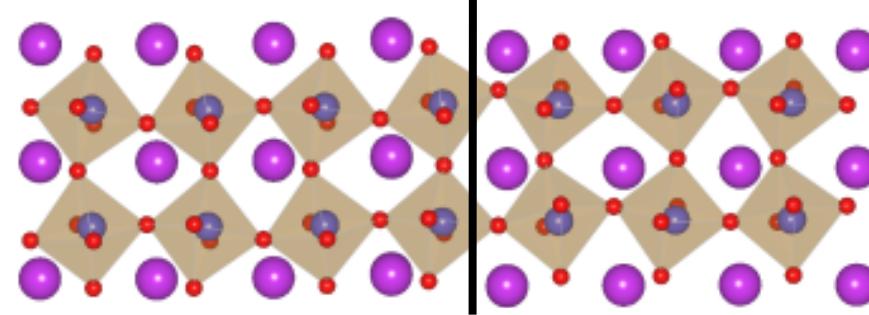


# Domain wall structures

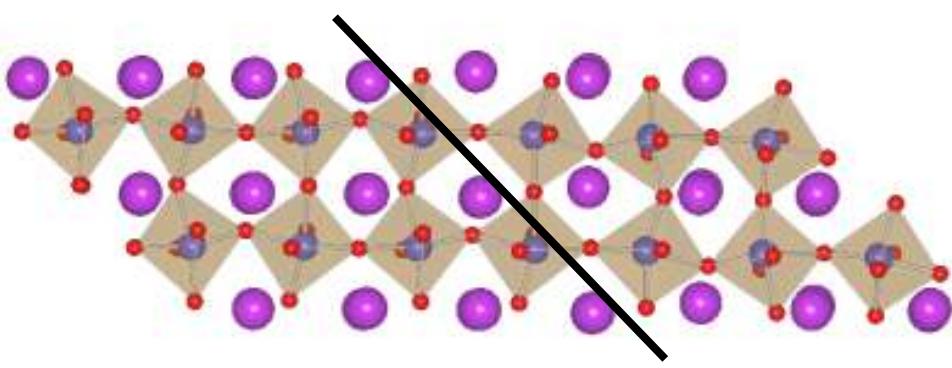
71° wall



109° wall

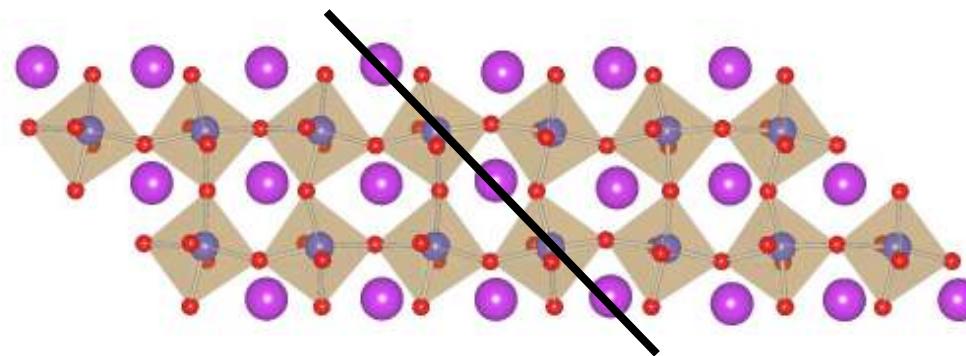


180° wall



# Domain wall structures – electronic structure

71° wall



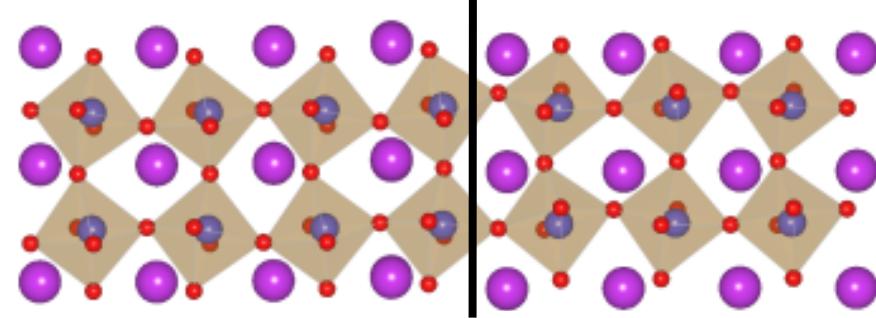
$$E_D = 0.36 \text{ J/m}^2$$

$$\Delta V = 0.02 \text{ eV}$$

$$\Delta E_g = -0.05 \text{ eV}$$

109° wall

very stable  
conducting!



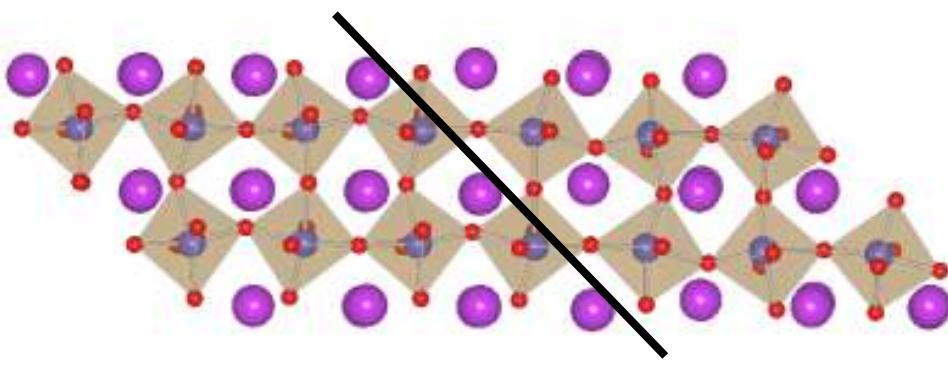
$$E_D = 0.21 \text{ J/m}^2$$

$$\Delta V = 0.18 \text{ eV}$$

$$\Delta E_g = -0.20 \text{ eV}$$

180° wall

conducting!



$$E_D = 1.81 \text{ J/m}^2$$

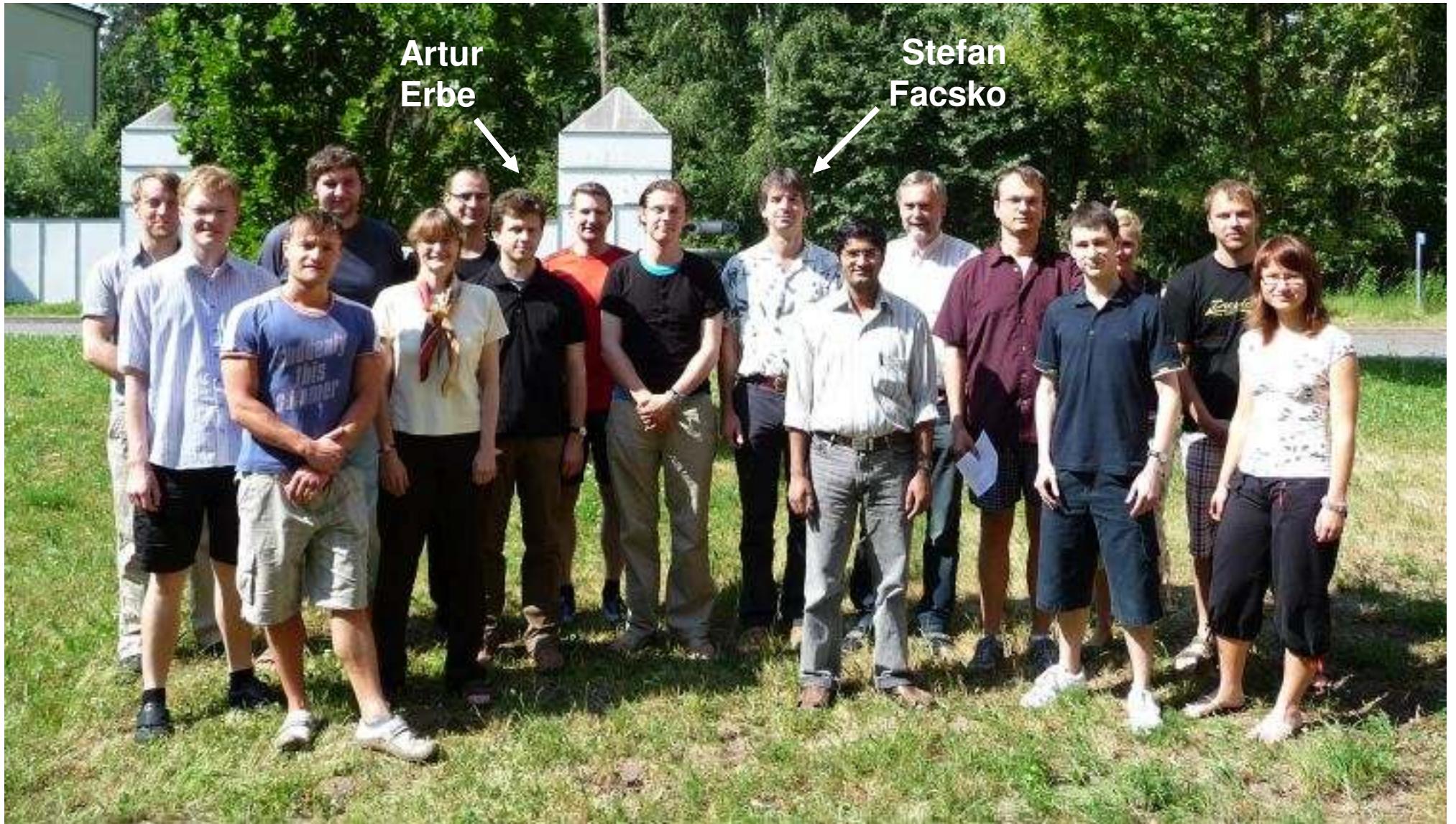
$$\Delta V = 0.15 \text{ eV}$$

$$\Delta E_g = -0.10 \text{ eV}$$

# Conclusions

- § Hopping transport
  - § Parameter transfer first-principle to classical transport
  - § Transport without bias by shuttling
- § Ballistic transport
  - § Model derivation from first-principles data
  - § Elastomechanic metal-insulator transition
- § Transport at defects in the bulk
  - § Existence of strong surface/interface polarizations
  - § Origin of conductivity at domain walls





## § Collaborators @ FZD

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A. Lubk (Rother)

C. Olbrich

I. Popov

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F. Besenbacher (Aarhus)

R. Tenne (Weizman)

L.M. Eng (Dresden)

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A.N. Enyashin (Ekaterinburg)

N. Spaldin (Santa Barbara)

## § Euros

DFG, BMBF, DAAD, GIF

# Thank you!



**Forschungszentrum  
Dresden** Rossendorf

